

## Memory FeRAM

### 64 K (8 K × 8) Bit SPI

## MB85RS64T

#### ■ DESCRIPTION

MB85RS64T is a FeRAM (Ferroelectric Random Access Memory) chip in a configuration of 8,192 words × 8 bits, using the ferroelectric process and silicon gate CMOS process technologies for forming the nonvolatile memory cells.

MB85RS64T adopts the Serial Peripheral Interface (SPI).

The MB85RS64T is able to retain data without using a back-up battery, as is needed for SRAM.

The memory cells used in the MB85RS64T can be used for  $10^{13}$  read/write operations, which is a significant improvement over the number of read and write operations supported by Flash memory and E<sup>2</sup>PROM.

MB85RS64T does not take long time to write data like Flash memories or E<sup>2</sup>PROM, and MB85RS64T takes no wait time.

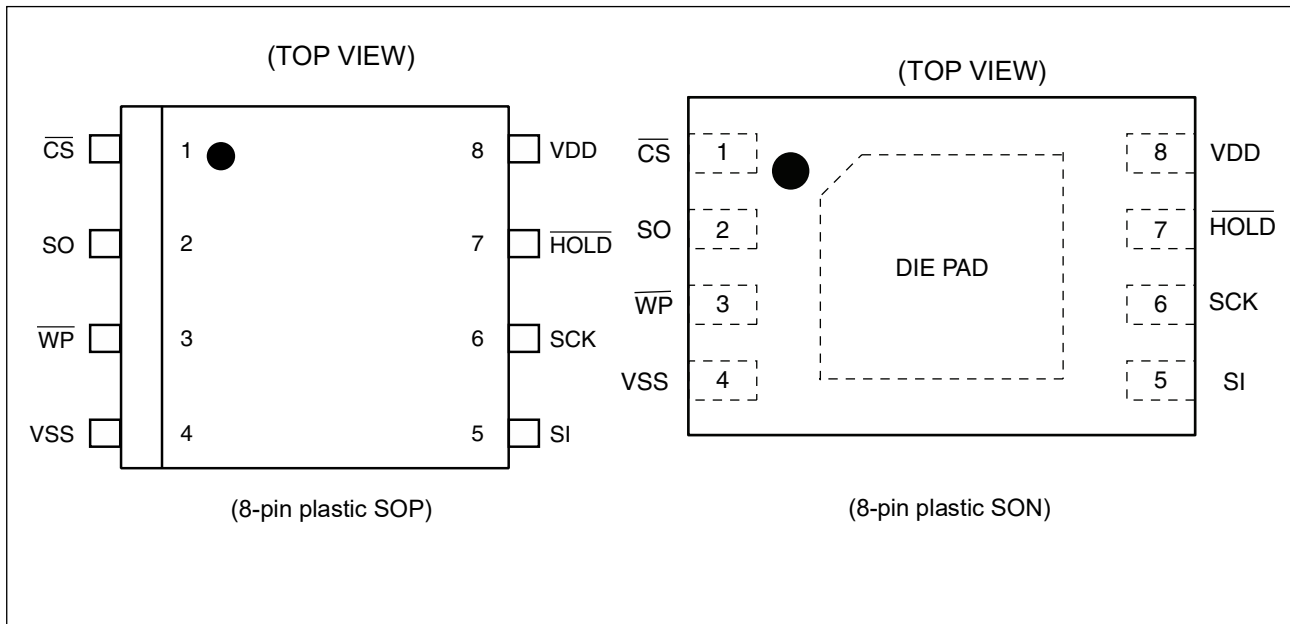
#### ■ FEATURES

- Bit configuration : 8,192 words × 8 bits
- Serial Peripheral Interface : SPI (Serial Peripheral Interface)  
Correspondent to SPI mode 0 (0, 0) and mode 3 (1, 1)
- Operating frequency : 10 MHz (Max)
- High endurance :  $10^{13}$  times / byte
- Data retention : 10 years ( + 85 °C)
- Operating power supply voltage : 1.8 V to 3.6 V
- Low power consumption : Operating power supply current 0.8 mA (Max@10 MHz)  
Standby current 9 μA (Typ)
- Operation ambient temperature range : - 40 °C to +85 °C
- Package : 8-pin plastic SOP  
8-pin plastic SON  
RoHS compliant

Fujitsu Semiconductor Memory Solutions Limited has changed its name to RAMXEED Limited. RAMXEED Limited will continue to offer and support existing products while maintaining Fujitsu's part number unchanged.

# MB85RS64T

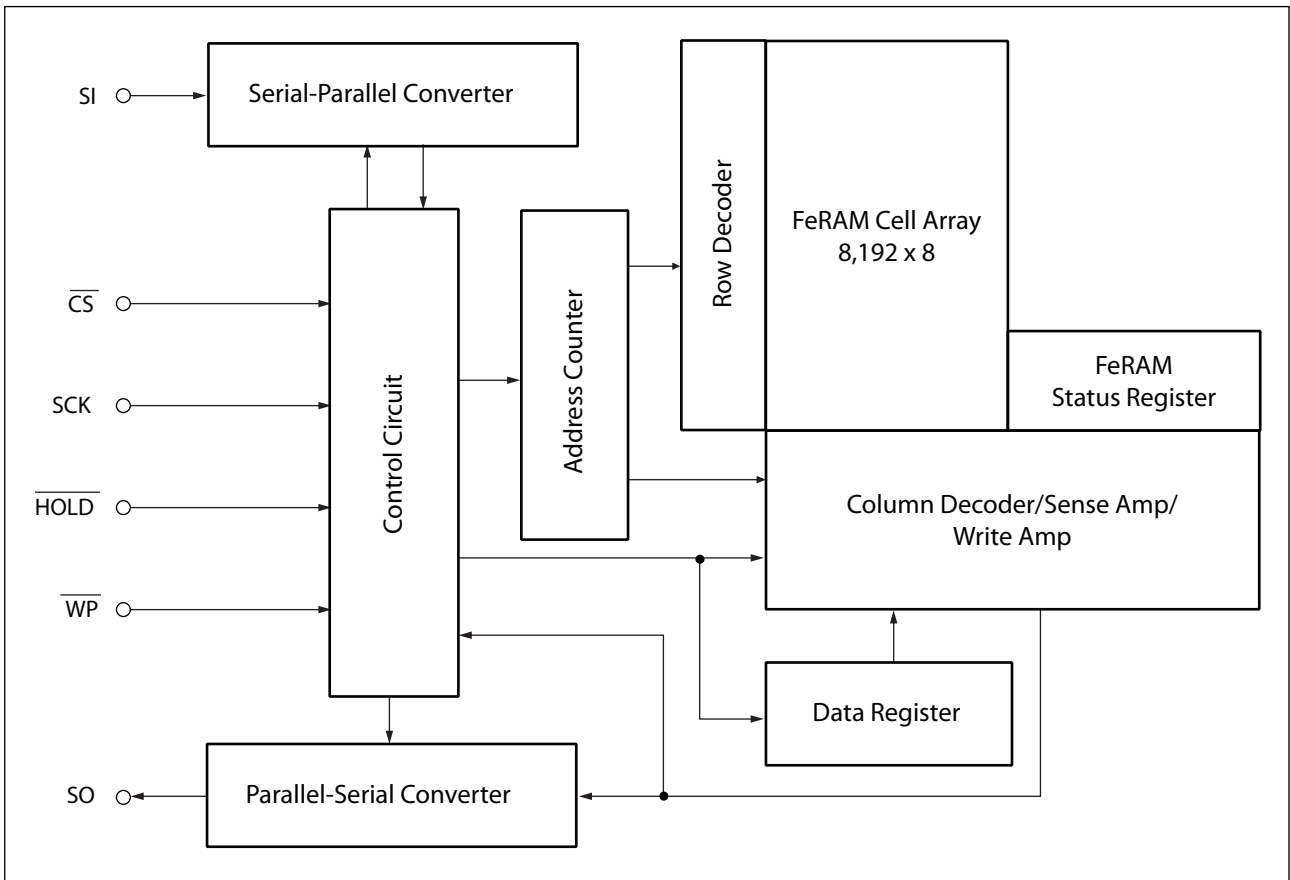
## ■ PIN ASSIGNMENT



## ■ PIN FUNCTIONAL DESCRIPTIONS

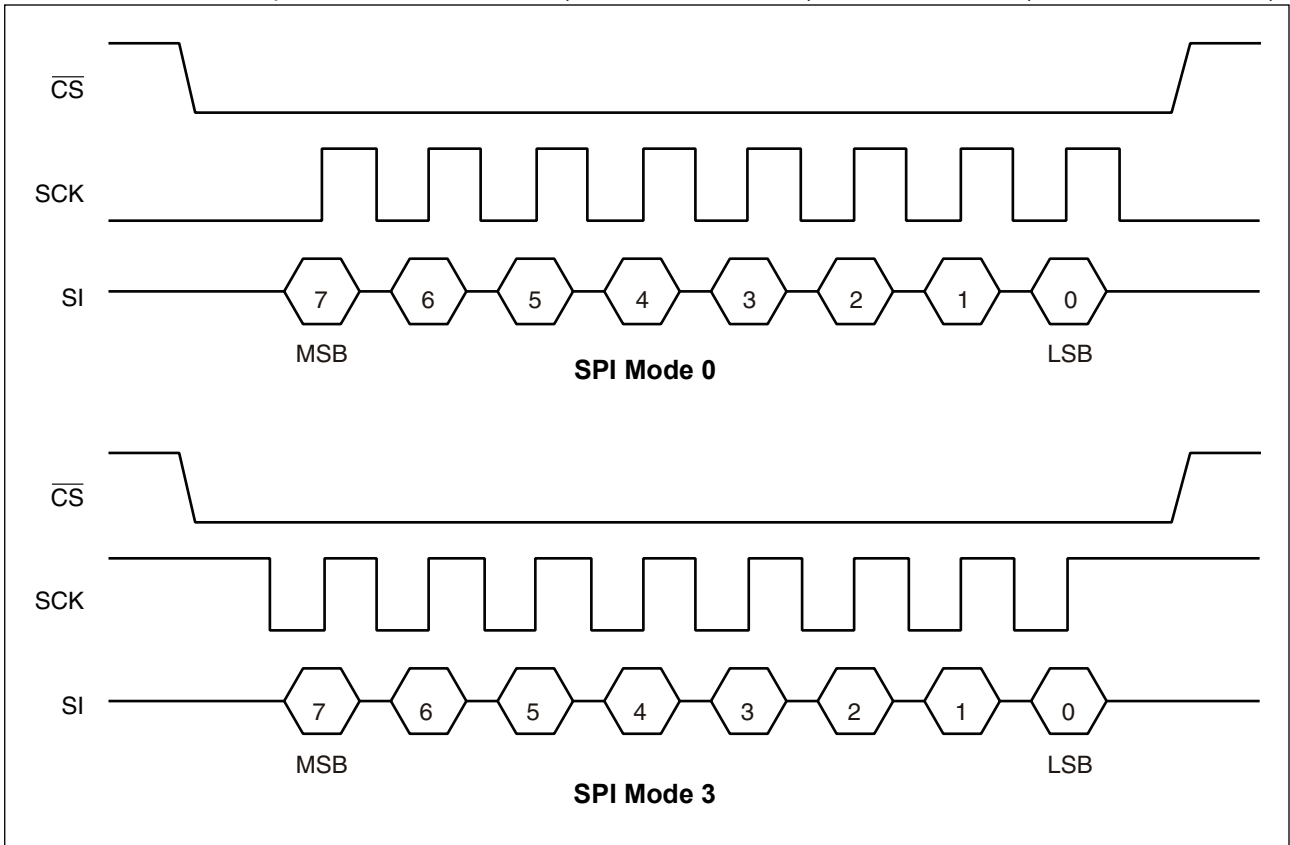
Pin No.	Pin Name	Functional description
1	$\overline{CS}$	Chip Select pin This is an input pin to make chip select. When $\overline{CS}$ is the "H" level, device is in deselect (standby) status and SO becomes High-Z. Inputs from other pins are ignored at this time. When $\overline{CS}$ is the "L" level, device is in select (active) status. $\overline{CS}$ has to be the "L" level before inputting op-code.
3	$\overline{WP}$	Write Protect pin This is a pin to control writing to a status register. The writing of status register (see "■ STATUS REGISTER") is protected in related with $\overline{WP}$ and WPEN. See "■ WRITING PROTECT" for detail.
7	$\overline{HOLD}$	Hold pin This pin is used to interrupt serial input/output without making chip deselect. When $\overline{HOLD}$ is the "L" level, hold operation is activated, SO becomes High-Z, and SCK and SI become don't care. While the hold operation, $\overline{CS}$ shall be retained the "L" level.
6	SCK	Serial Clock pin This is a clock input pin to input/output serial data. SI is loaded synchronously to a rising edge, SO is output synchronously to a falling edge.
5	SI	Serial Data Input pin This is an input pin of serial data. This inputs op-code, address, and writing data.
2	SO	Serial Data Output pin This is an output pin of serial data. Reading data of FeRAM memory cell array and status register are output. This is High-Z during standby.
8	VDD	Supply Voltage pin
4	VSS	Ground pin
DIE PAD	—	It is allowed for the DIE PAD on the bottom of the SON8 package to be floating (no connection to anything) or to be connected to VSS.

## ■ BLOCK DIAGRAM



## ■ SPI MODE

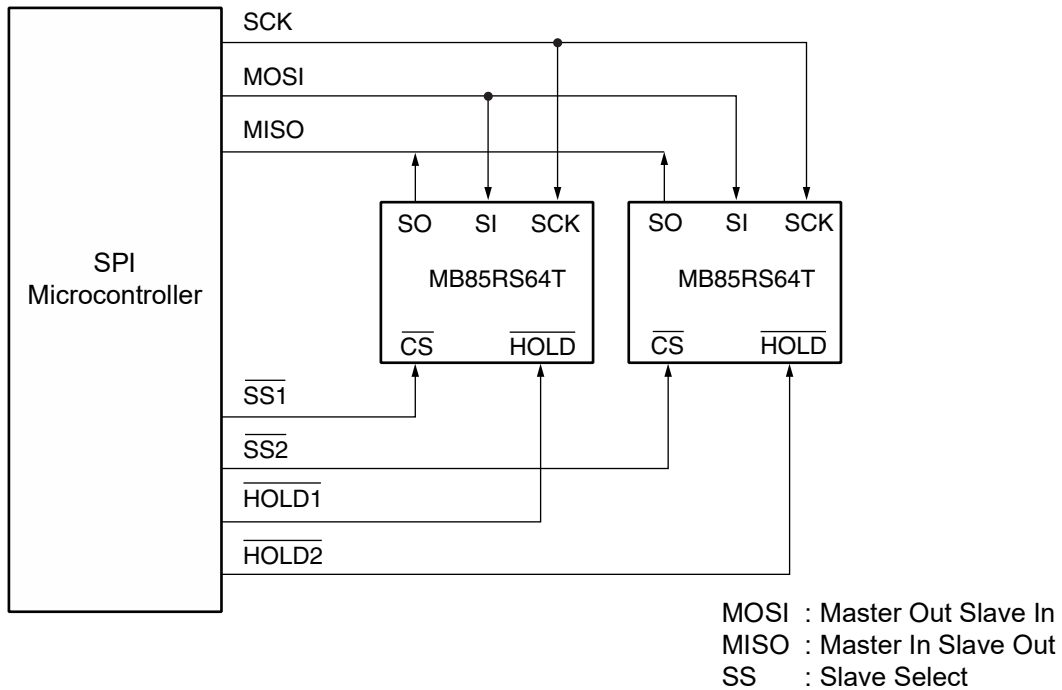
MB85RS64T corresponds to the SPI mode 0 (CPOL = 0, CPHA = 0), and SPI mode 3 (CPOL = 1, CPHA = 1).



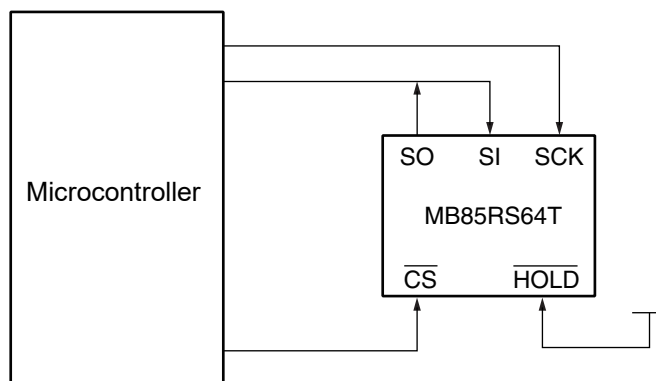
# MB85RS64T

## ■ SERIAL PERIPHERAL INTERFACE (SPI)

MB85RS64T works as a slave of SPI. More than 2 devices can be connected by using microcontroller equipped with SPI port. By using a microcontroller not equipped with SPI port, SI and SO can be bus connected to use.



**System Configuration with SPI Port**



**System Configuration without SPI Port**

## ■ STATUS REGISTER

Bit No.	Bit Name	Function
7	WPEN	Status Register Write Protect This is a bit composed of nonvolatile memories (FeRAM). WPEN protects writing to a status register (see “■ WRITING PROTECT”) relating with $\overline{WP}$ input. Writing with the WRSR command and reading with the RDSR command are possible.
6 to 4	—	Not Used Bits These are bits composed of nonvolatile memories, writing with the WRSR command is possible, and “000” is written before shipment. These bits are not used but they are read with the RDSR command.
3	BP1	Block Protect This is a bit composed of nonvolatile memory. This defines size of write protect block for the WRITE command (see “■ BLOCK PROTECT”). Writing with the WRSR command and reading with the RDSR command are possible.
2	BP0	
1	WEL	Write Enable Latch This indicates FeRAM Array and status register are writable. The WREN command is for setting, and the WRDI command is for resetting. With the RDSR command, reading is possible but writing is not possible with the WRSR command. WEL is reset after the following operations. After power ON. After WRDI command recognition.
0	0	This is a bit fixed to “0”.

## ■ OP-CODE

MB85RS64T accepts 8 kinds of command specified in op-code. Op-code is a code composed of 8 bits shown in the table below. Do not input invalid codes other than those codes. If CS is risen while inputting op-code, the command are not performed.

Name	Description	Op-code
WREN	Set Write Enable Latch	0000 0110 <sub>B</sub>
WRDI	Reset Write Enable Latch	0000 0100 <sub>B</sub>
RDSR	Read Status Register	0000 0101 <sub>B</sub>
WRSR	Write Status Register	0000 0001 <sub>B</sub>
READ	Read Memory Code	0000 0011 <sub>B</sub>
WRITE	Write Memory Code	0000 0010 <sub>B</sub>
RDID	Read Device ID	1001 1111 <sub>B</sub>
SLEEP	Sleep Mode	1011 1001 <sub>B</sub>
RFU	Reserved for future use <sup>*1</sup>	0000 1011 <sub>B</sub>

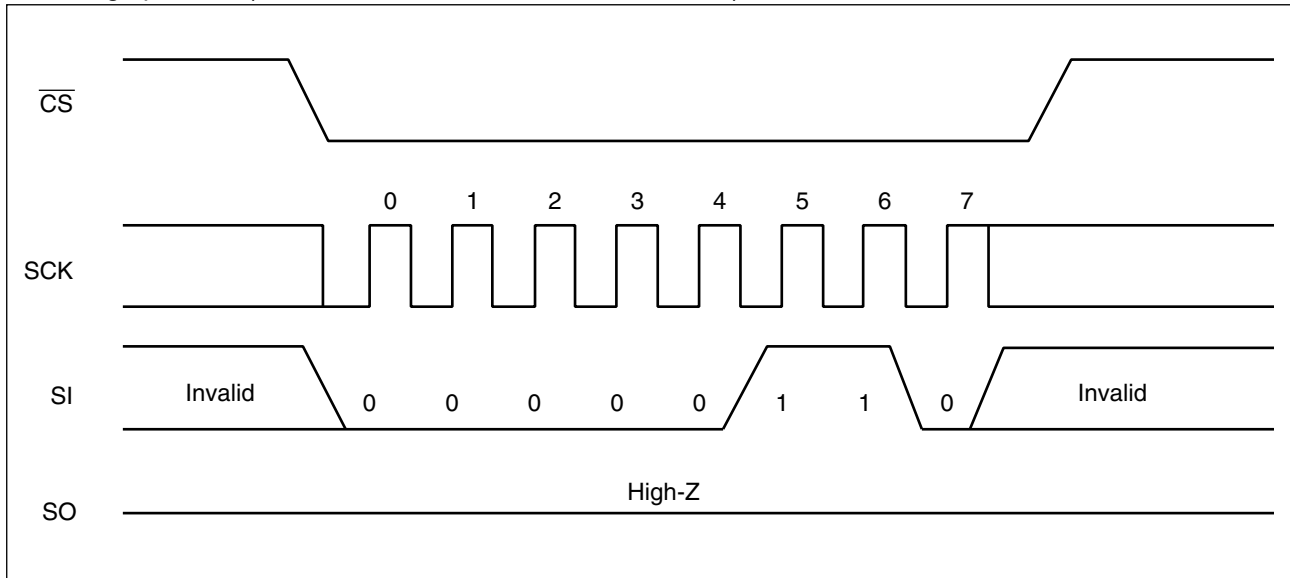
\*1:When this command is input, SO output will be unvalued.

# MB85RS64T

## ■ COMMAND

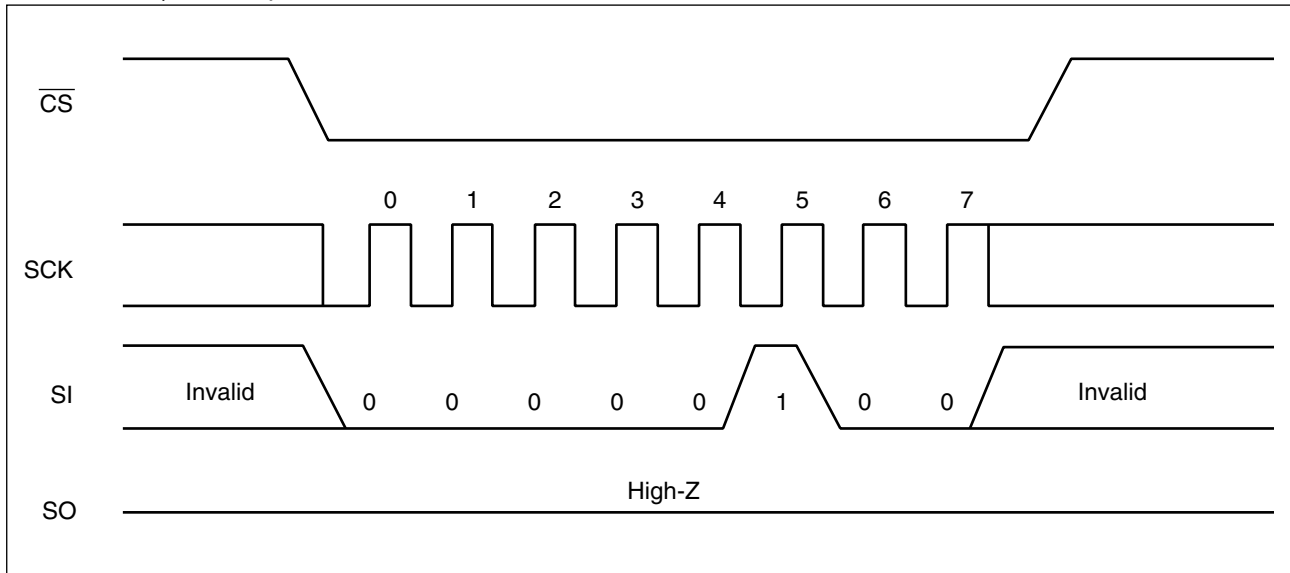
### • WREN

The WREN command sets WEL (Write Enable Latch) . WEL shall be set with the WREN command before writing operation (WRSR command and WRITE command) .



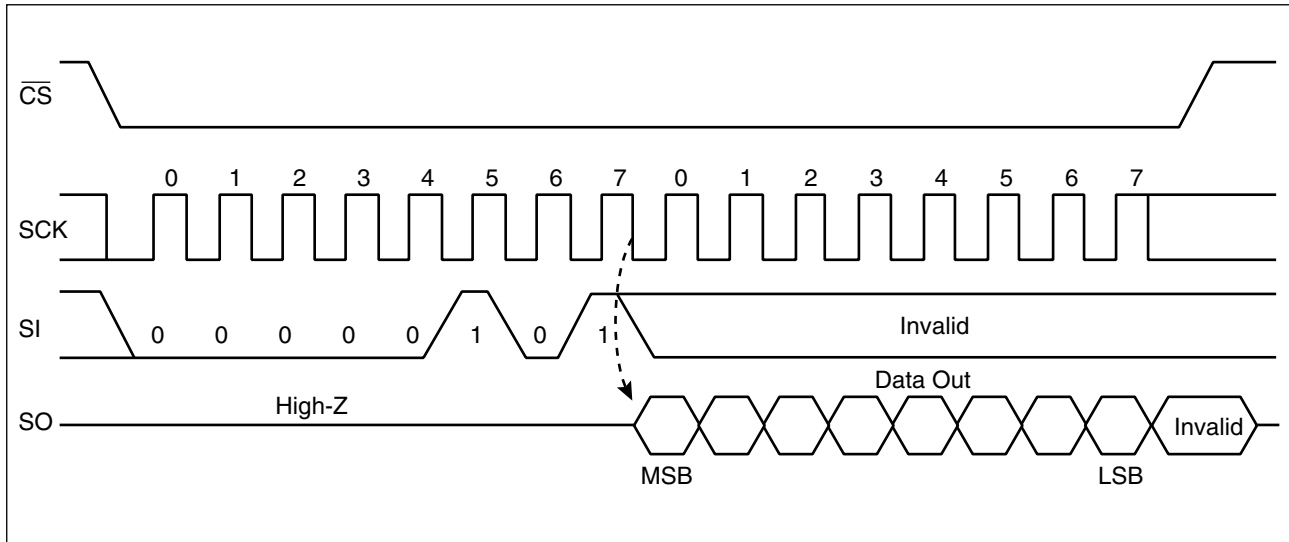
### • WRDI

The WRDI command resets WEL (Write Enable Latch) . Writing operation (WRITE command and WRSR command) are not performed when WEL is reset.



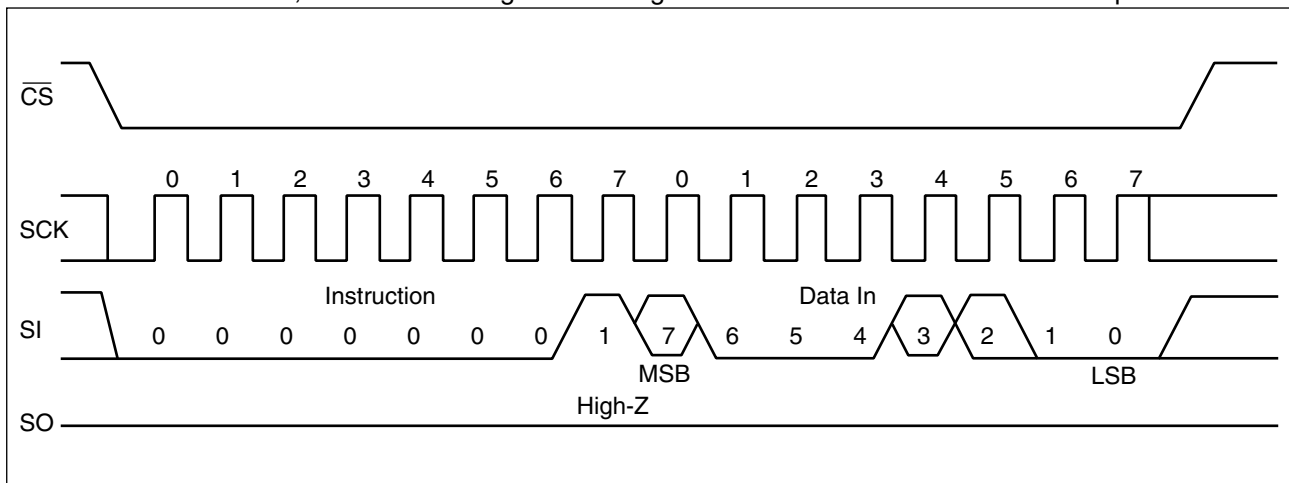
## • RDSR

The RDSR command reads status register data. After op-code of RDSR is input to SI, 8-cycle clock is input to SCK. The SI value is invalid during this time. SO is output synchronously to a falling edge of SCK. In the RDSR command, repeated reading of status register is enabled by sending SCK continuously before rising of  $\overline{CS}$ .



## • WRSR

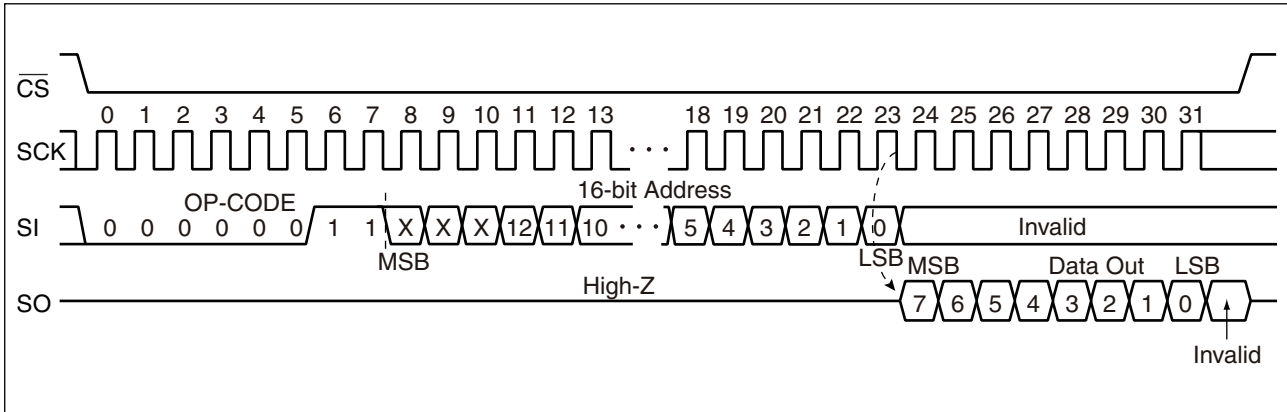
The WRSR command writes data to the nonvolatile memory bit of status register. After performing WRSR op-code to a SI pin, 8 bits writing data is input. WEL (Write Enable Latch) is not able to be written with WRSR command. A SI value correspondent to bit 1 is ignored. Bit 0 of the status register is fixed to "0" and cannot be written. The SI value corresponding to bit 0 is ignored. The  $\overline{WP}$  signal level shall be fixed before performing the WRSR command, and do not change the  $\overline{WP}$  signal level until the end of command sequence.



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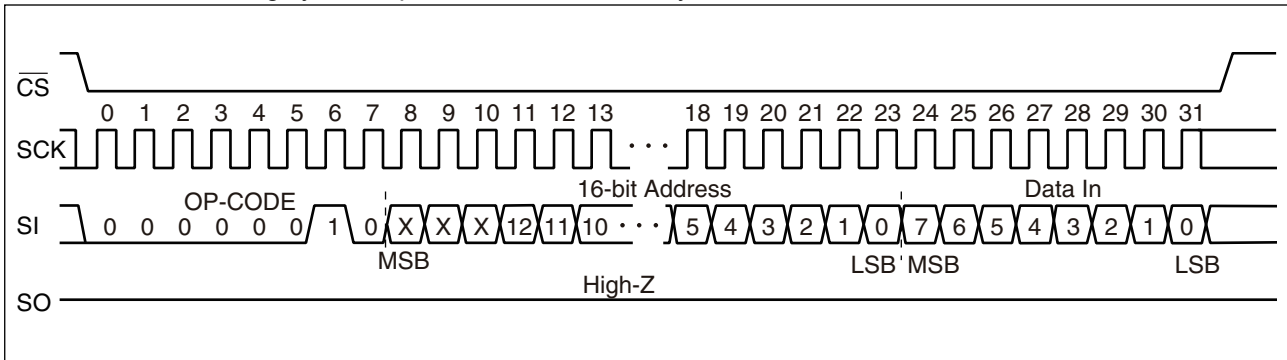
## • READ

The READ command reads FeRAM memory cell array data. Arbitrary 16 bits address and op-code of READ are input to SI. The 3-bit upper address bit is invalid. Then, 8-cycle clock is input to SCK. SO is output synchronously to the falling edge of SCK. While reading, the SI value is invalid. When  $\overline{CS}$  is risen, the READ command is completed, but keeps on reading with automatic address increment which is enabled by continuously sending clocks to SCK in unit of 8 cycles before  $\overline{CS}$  rising. When it reaches the most significant address, it rolls over to the starting address, and reading cycle keeps on infinitely.



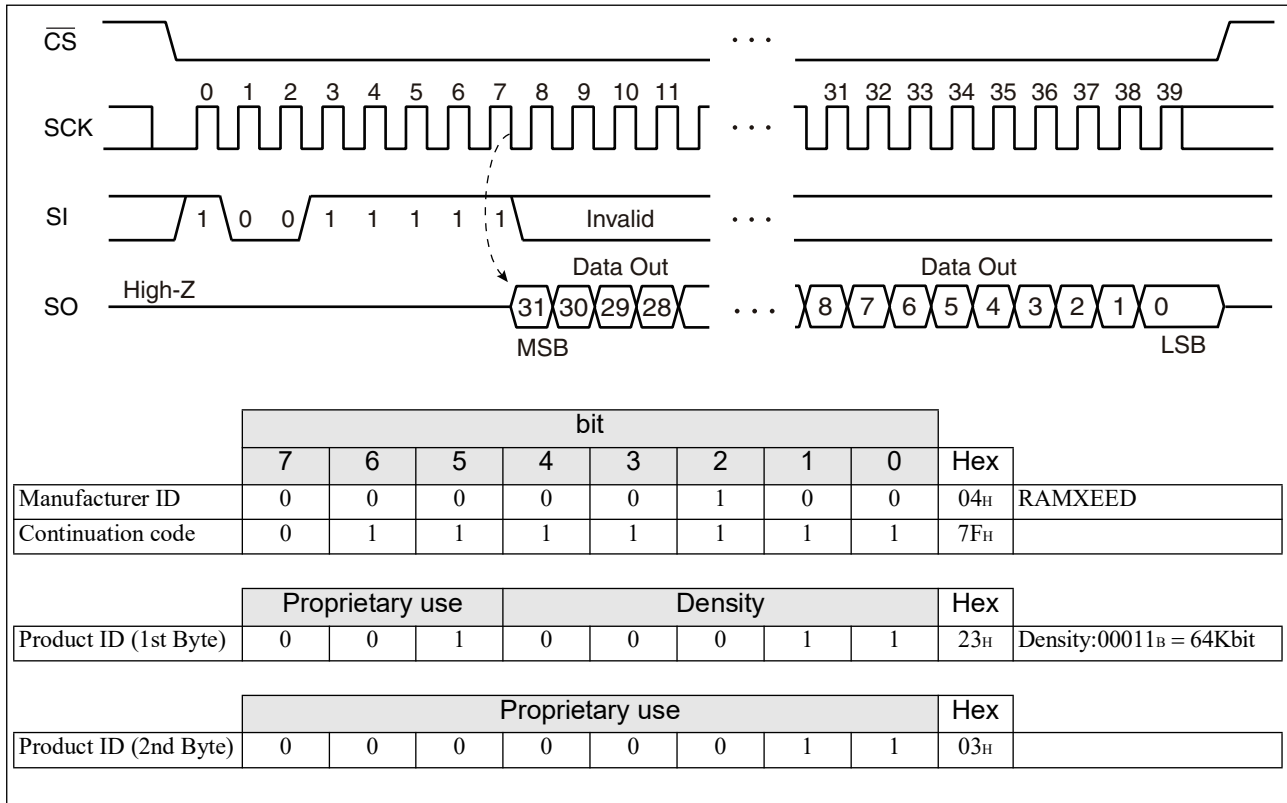
## • WRITE

The WRITE command writes data to FeRAM memory cell array. WRITE op-code, arbitrary 16 bits of address and 8 bits of writing data are input to SI. The 3-bit upper address bit is invalid. When 8 bits of writing data is input, data is written to FeRAM memory cell array. Risen  $\overline{CS}$  will terminate the WRITE command. However, if you continue sending the writing data for 8 bits each before  $\overline{CS}$  rising, it is possible to continue writing with automatic address increment. When it reaches the most significant address, it rolls over to the starting address, and writing cycle keeps on continued infinitely.



## •RDID

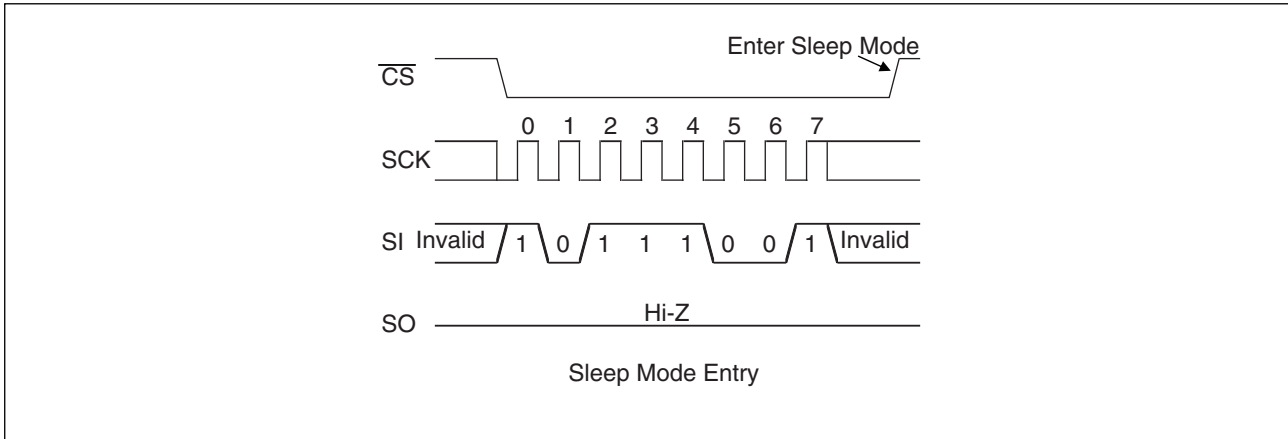
The RDID command reads fixed Device ID. After performing RDID op-code to SI, 32-cycle clock is input to SCK. The SI value is invalid for this time. SO is output synchronously to a falling edge of SCK. The output is in order of Manufacturer ID (8bit)/Continuation code (8bit)/Product ID (1st Byte)/Product ID (2nd Byte). In the RDID command, SO holds the output state of the last bit in 32-bit Device ID until  $\overline{CS}$  is risen.



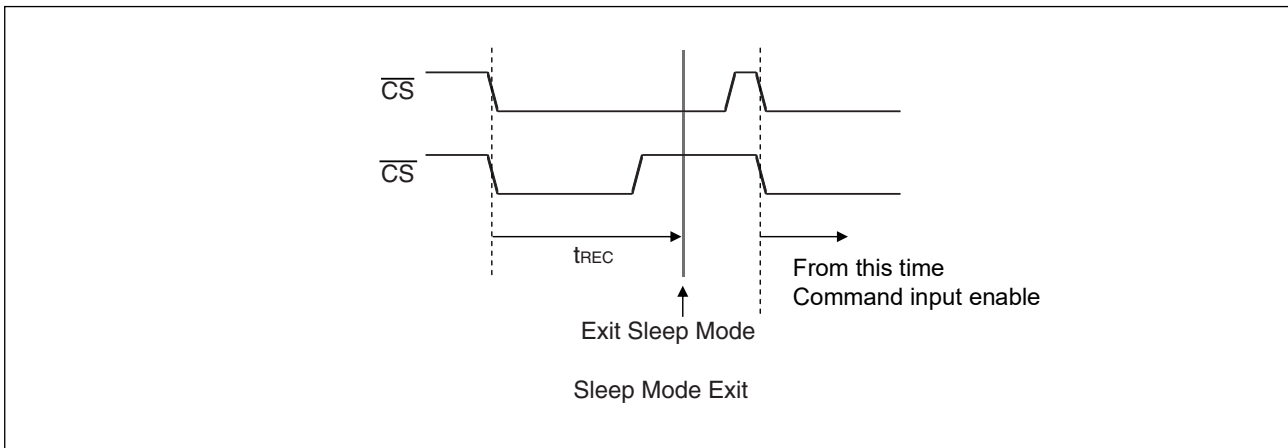
## • SLEEP

The SLEEP command shifts the LSI to a low power mode called "SLEEP mode". The transition to the SLEEP mode is carried out at the rising edge of  $\overline{CS}$  after operation code in the SLEEP command. However, when at least one SCK clock is inputted before the rising edge of  $\overline{CS}$  after operation code in the SLEEP command, this SLEEP command is canceled.

After the SLEEP mode transition, SCK and SI inputs are ignored and SO changes to a Hi-Z state.



Returning to an normal operation from the SLEEP mode is carried out after  $t_{REC}$  (Max 400  $\mu$ s) time from the falling edge of  $\overline{CS}$  (see the figure below). It is possible to return  $\overline{CS}$  to H level before  $t_{REC}$  time. However, it is prohibited to bring down  $\overline{CS}$  to L level again during  $t_{REC}$  period.



## ■ BLOCK PROTECT

Writing protect block for WRITE command is configured by the value of BP0 and BP1 in the status register.

BP1	BP0	Protected Block
0	0	None
0	1	1800 <sub>H</sub> to 1FFF <sub>H</sub> (upper 1/4)
1	0	1000 <sub>H</sub> to 1FFF <sub>H</sub> (upper 1/2)
1	1	0000 <sub>H</sub> to 1FFF <sub>H</sub> (all)

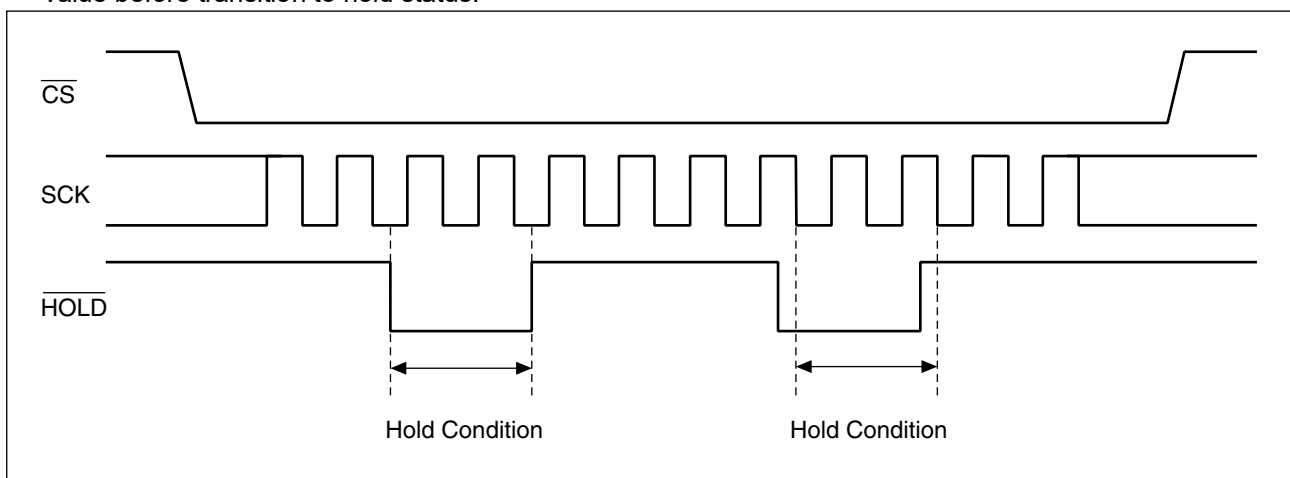
## ■ WRITING PROTECT

Writing operation of the WRITE command and the WRSR command are protected with the value of WEL, WPEN, WP as shown in the table.

WEL	WPEN	WP	Protected Blocks	Unprotected Blocks	Status Register
0	X	X	Protected	Protected	Protected
1	0	X	Protected	Unprotected	Unprotected
1	1	0	Protected	Unprotected	Protected
1	1	1	Protected	Unprotected	Unprotected

## ■ HOLD OPERATION

Hold status is retained without aborting a command if  $\overline{\text{HOLD}}$  is the "L" level while  $\overline{\text{CS}}$  is the "L" level. The timing for starting and ending hold status depends on the SCK to be the "H" level or the "L" level when a HOLD pin input is transitioned to the hold condition as shown in the diagram below. In case the  $\overline{\text{HOLD}}$  pin transitioned to "L" level when SCK is "L" level, return the  $\overline{\text{HOLD}}$  pin to "H" level at SCK being "L" level. In the same manner, in case the  $\overline{\text{HOLD}}$  pin transitioned to "L" level when SCK is "H" level, return the  $\overline{\text{HOLD}}$  pin to "H" level at SCK being "H" level. Arbitrary command operation is interrupted in hold status, SCK and SI inputs become don't care. And, SO becomes High-Z while reading command (RDSR, READ). If  $\overline{\text{CS}}$  is rising during hold status, a command is aborted. In case the command is aborted before its recognition, WEL holds the value before transition to hold status.



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## ■ ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Rating		Unit
		Min	Max	
Power supply voltage*	$V_{DD}$	- 0.5	+ 4.0	V
Input voltage*	$V_{IN}$	- 0.5	$V_{DD} + 0.5$	V
Output voltage*	$V_{OUT}$	- 0.5	$V_{DD} + 0.5$	V
Operation ambient temperature	$T_A$	- 40	+ 85	°C
Storage temperature	$T_{stg}$	- 55	+ 125	°C

\*:These parameters are based on the condition that  $V_{SS}$  is 0 V.

WARNING: Semiconductor devices may be permanently damaged by application of stress (including, without limitation, voltage, current or temperature) in excess of absolute maximum ratings. Do not exceed any of these ratings.

## ■ RECOMMENDED OPERATING CONDITIONS

Parameter	Symbol	Value			Unit
		Min	Typ	Max	
Power supply voltage <sup>*1</sup>	$V_{DD}$	1.8	3.3	3.6	V
Operation ambient temperature <sup>*2</sup>	$T_A$	- 40	—	+ 85	°C

\*1: These parameters are based on the condition that  $V_{SS}$  is 0 V.

\*2: Ambient temperature when only this device is working. Please consider it to be the almost same as the package surface temperature.

WARNING: The recommended operating conditions are required in order to ensure the normal operation of the semiconductor device. All of the device's electrical characteristics are warranted when the device is operated under these conditions.

Any use of semiconductor devices will be under their recommended operating condition. Operation under any conditions other than these conditions may adversely affect reliability of device and could result in device failure.

No warranty is made with respect to any use, operating conditions or combinations not represented on this data sheet. If you are considering application under any conditions other than listed herein, please contact sales representatives beforehand.

## ■ ELECTRICAL CHARACTERISTICS

### 1. DC Characteristics

(within recommended operating conditions)

Parameter	Symbol	Condition	Value			Unit
			Min	Typ	Max	
Input leakage current*1	$ I_{LI} $	$\overline{WP}$ , $\overline{HOLD}$ , $\overline{SCK}$ , $\overline{CS}$ , SI = 0 V to $V_{DD}$	—	—	1	$\mu A$
Output leakage current*2	$ I_{LO} $	SO = 0 V to $V_{DD}$	—	—	1	$\mu A$
Operating power supply current	$I_{DD}$	SCK = 0.1MHz	—	15	—	$\mu A$
		SCK = 1 MHz	—	60	100	$\mu A$
		SCK = 10 MHz	—	500	800	$\mu A$
Standby current	$I_{SB}$	$\overline{SCK} = \overline{SI} = \overline{CS} = V_{DD}$	—	9	12	$\mu A$
Sleep current	$I_{ZZ}$	$\overline{CS} = V_{DD}$ all inputs $V_{SS}$ or $V_{DD}$	—	4	6	$\mu A$
Input high voltage	$V_{IH}$	$V_{DD} = 1.8 V$ to $3.6 V$	$V_{DD} \times 0.7$	—	$V_{DD} + 0.5$	V
Input low voltage	$V_{IL}$	$V_{DD} = 1.8 V$ to $3.6 V$	-0.5	—	$V_{DD} \times 0.3$	V
Output high voltage	$V_{OH}$	$I_{OH} = -2 mA$	$V_{DD} - 0.5$	—	$V_{DD}$	V
Output low voltage	$V_{OL}$	$I_{OL} = 2 mA$	$V_{SS}$	—	0.4	V

\*1: Applicable to;  $\overline{CS}$ ,  $\overline{WP}$ ,  $\overline{HOLD}$ ,  $\overline{SCK}$ , SI

\*2: Applicable to; SO

:

### 2. AC Characteristics

Parameter	Symbol	Value		Unit
		Min	Max	
SCK clock frequency	$f_{CK}$	0	10	MHz
Clock high time	$t_{CH}$	20	—	ns
Clock low time	$t_{CL}$	20	—	ns
Chip select set up time	$t_{CSU}$	10	—	ns
Chip select hold time	$t_{CSH}$	10	—	ns
Output disable time	$t_{OD}$	—	12	ns
Output data valid time	$t_{ODV}$	—	18	ns
Output hold time	$t_{OH}$	0	—	ns
Deselect time	$t_D$	40	—	ns
Data rising time	$t_R$	—	50	ns
Data falling time	$t_F$	—	50	ns
Data set up time	$t_{SU}$	5	—	ns
Data hold time	$t_H$	5	—	ns
$\overline{HOLD}$ set up time	$t_{HS}$	10	—	ns
$\overline{HOLD}$ hold time	$t_{HH}$	10	—	ns
$\overline{HOLD}$ output floating time	$t_{HZ}$	—	20	ns
$\overline{HOLD}$ output active time	$t_{LZ}$	—	20	ns
SLEEP resume time	$t_{REC}$	—	400	$\mu s$

# MB85RS64T

## AC Test Condition

Power supply voltage : 1.8 V to 3.6 V

Operation ambient temperature : - 40 °C to + 85 °C

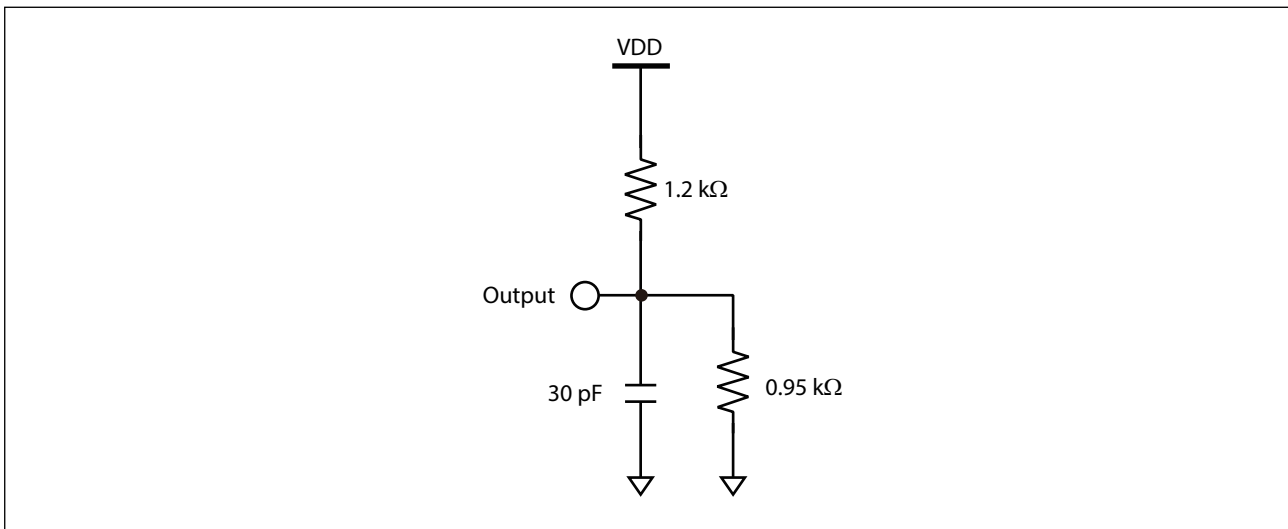
Input voltage magnitude :  $0 \leq V_{IL} \leq 0.2 \times V_{DD}$  ,  $0.8 \times V_{DD} \leq V_{IH} \leq V_{DD}$ ,

Input rising time : 5 ns

Input falling time : 5 ns

Input judge level :  $V_{DD}/2$

Output judge level :  $V_{DD}/2$  AC Load Equivalent Circuit

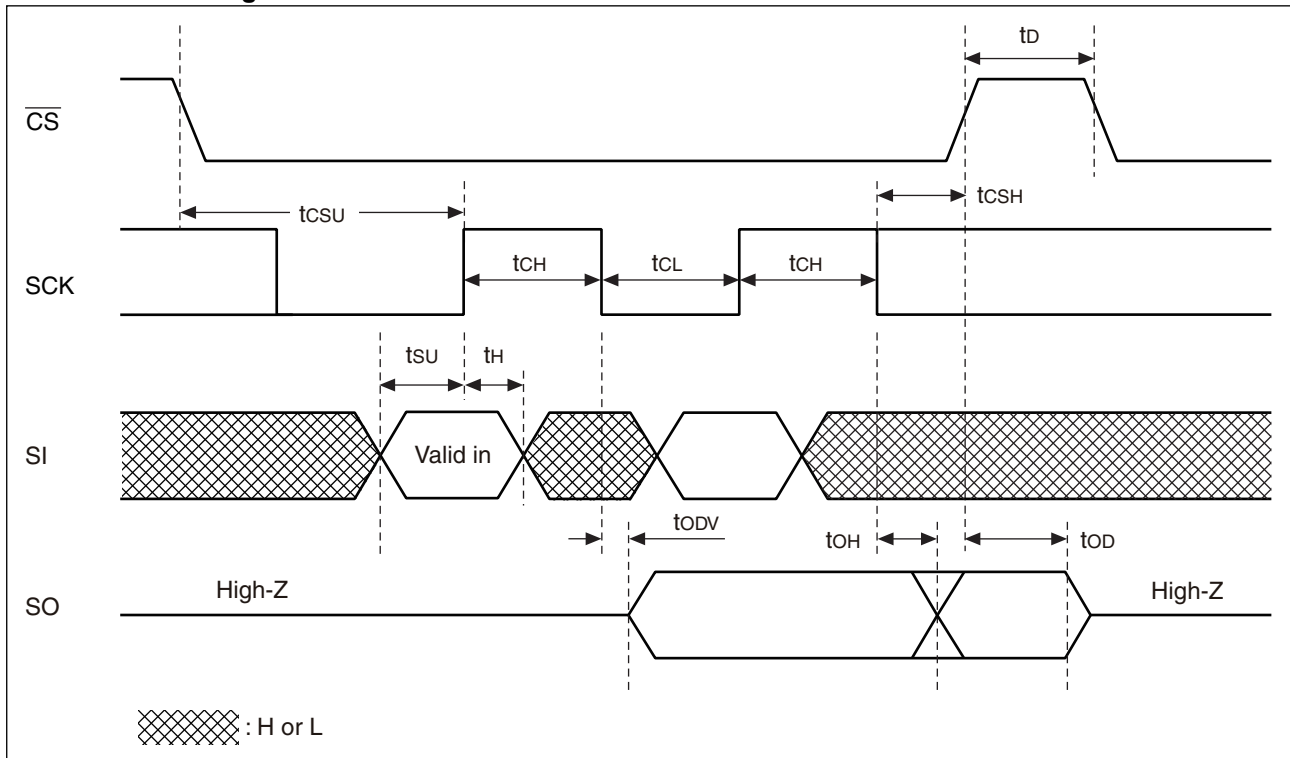


## 3. Pin Capacitance

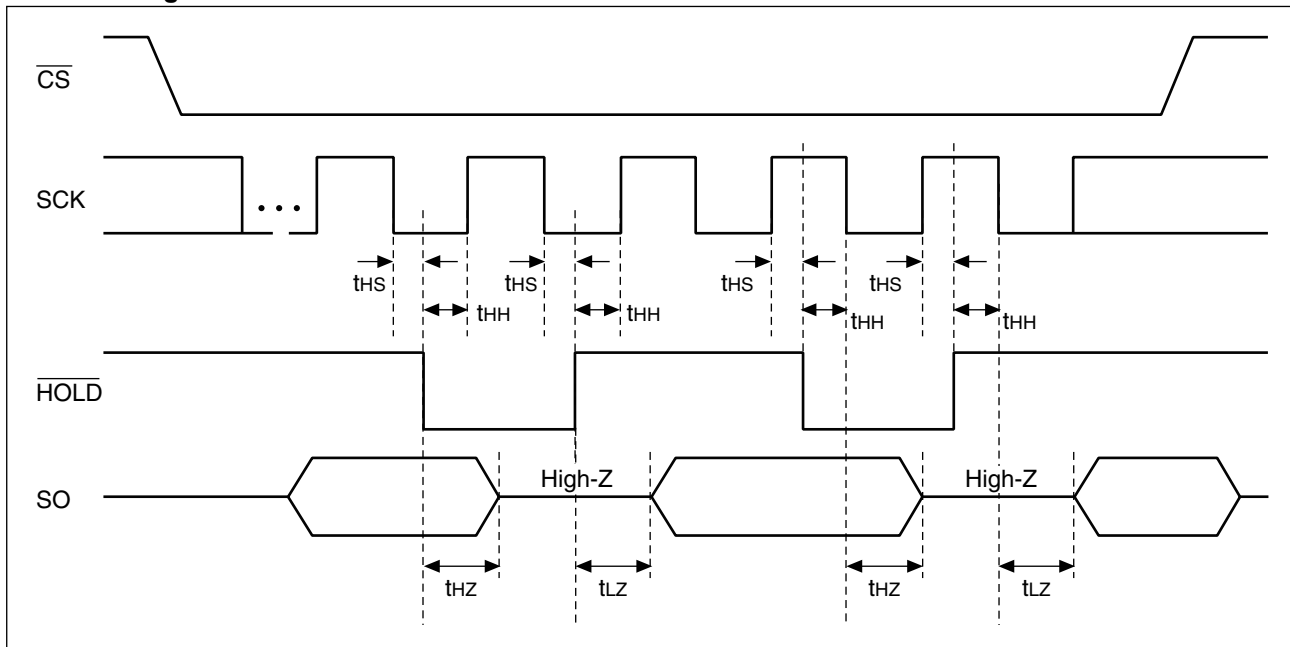
Parameter	Symbol	Conditions	Value		Unit
			Min	Max	
Output capacitance	$C_o$	$V_{DD}=3.3V,$ $V_{DD} = V_{IN} = V_{OUT} = 0 V$ $f = 1 MHz, T_A = + 25 ^\circ C$	—	8	pF
Input capacitance	$C_i$		—	6	pF

## ■ TIMING DIAGRAM

### • Serial Data Timing

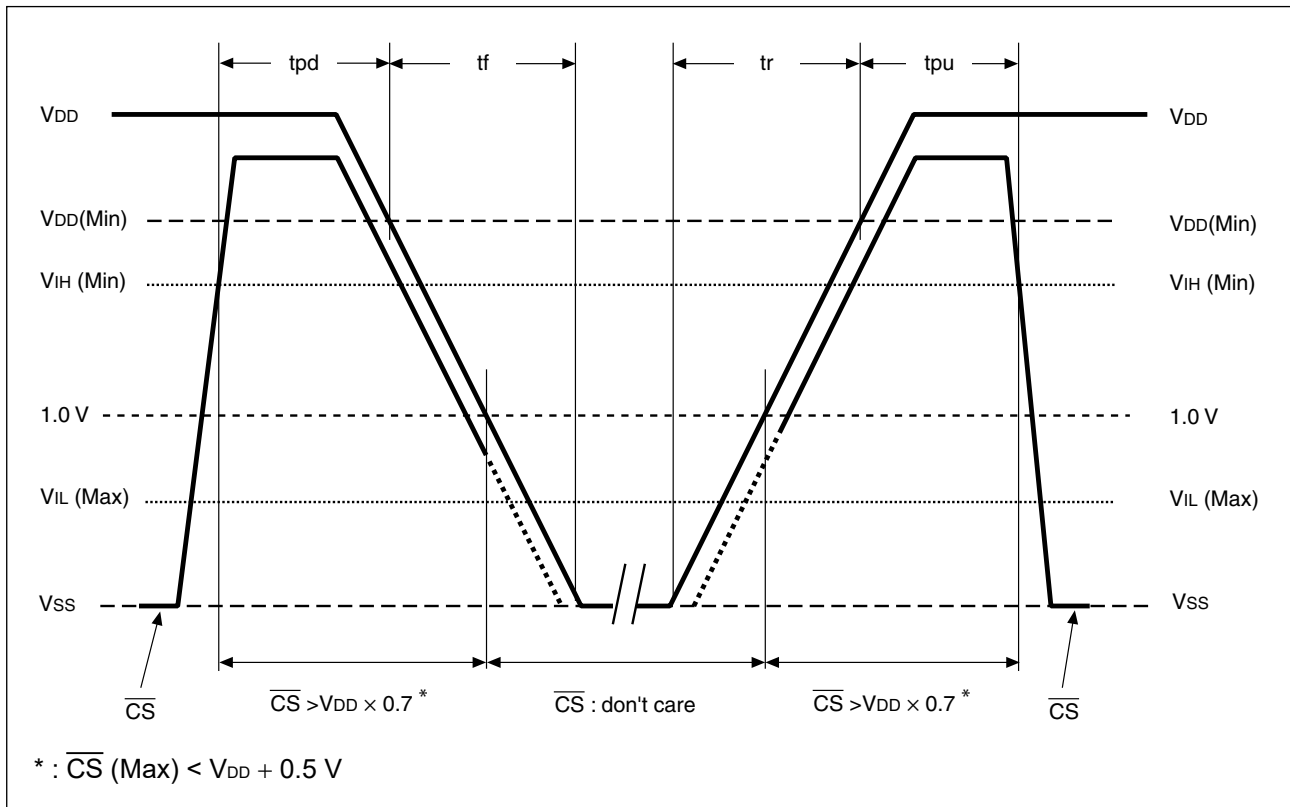


### • Hold Timing



# MB85RS64T

## ■ POWER ON/OFF SEQUENCE



Parameter	Symbol	Value		Unit
		Min	Max	
$\overline{CS}$ level hold time at power OFF	tpd	400	—	ns
$\overline{CS}$ level hold time at power ON	tpu	250	—	$\mu\text{s}$
Power supply rising time	tr	0.05	—	ms/V
Power supply falling time	tf	0.1	—	ms/V

If the device does not operate within the specified conditions of read cycle, write cycle or power on/off sequence, memory data can not be guaranteed.

## ■ FeRAM CHARACTERISTICS

Item	Min	Max	Unit	Parameter
Read/Write Endurance*1	$10^{13}$	—	Times/byte	Operation Ambient Temperature $T_A = +85 \text{ }^\circ\text{C}$
Data Retention*2	10	—	Years	Operation Ambient Temperature $T_A = +85 \text{ }^\circ\text{C}$

\*1 : Total number of reading and writing defines the minimum value of endurance, as an FeRAM memory operates with destructive readout mechanism.

\*2 : Minimum values define retention time of the first reading/writing data right after shipment.

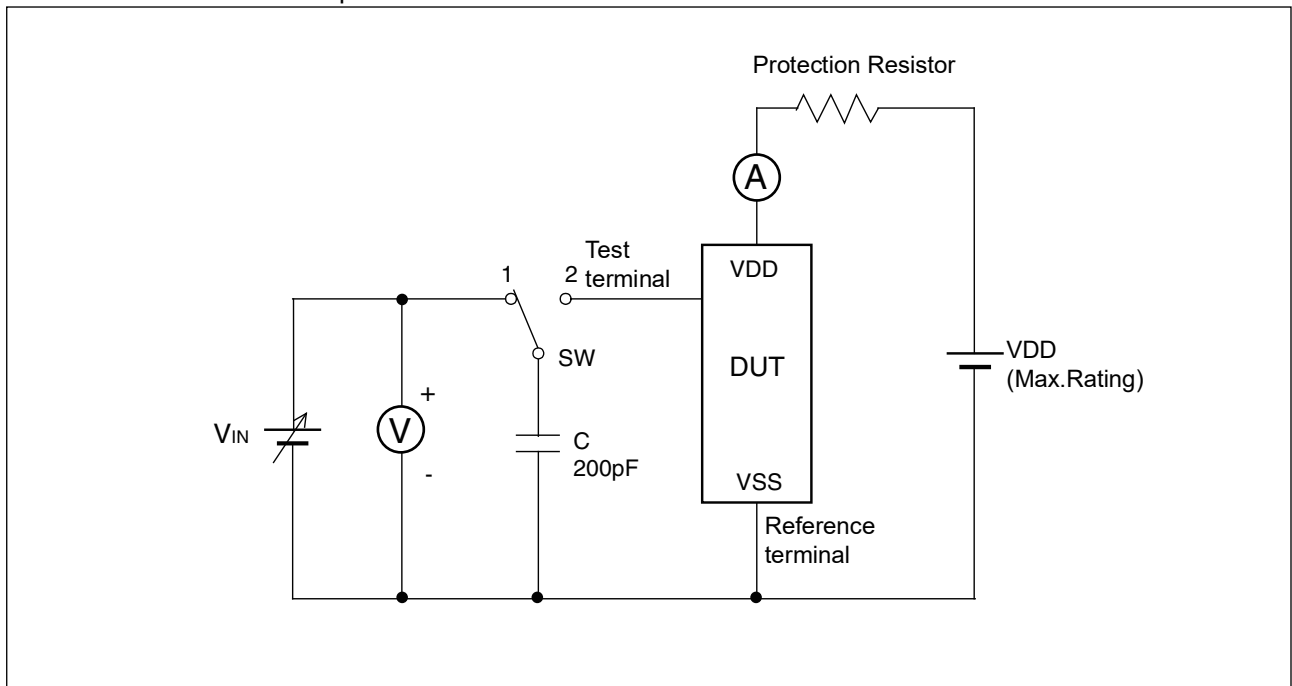
## ■ NOTE ON USE

We recommend programming of the device after reflow. Data written before reflow cannot be guaranteed.

## ■ ESD AND LATCH-UP

Test	DUT	Value
ESD HBM (Human Body Model) JESD22-A114 compliant	MB85RS64TPNF-G-JNE2	$\geq  2000 \text{ V} $
ESD CDM (Charged Device Model) JESD22-C101 compliant	MB85RS64TPNF-G-JNERE2 MB85RS64TPNF-G-AME2 MB85RS64TPNF-G-AMERE2	$\geq  1000 \text{ V} $
Latch-Up (C-V Method) Proprietary method	MB85RS64TPN-G-AMEWE1	$\geq  200 \text{ V} $

- C-V method of Latch-Up Resistance Test



Note : Charge voltage alternately switching 1 and 2 approximately 2 sec interval. This switching process is considered as one cycle.  
Repeat this process 5 times. However, if the latch-up condition occurs before completing 5 times, this test must be stopped immediately.

## ■ REFLOW CONDITIONS AND FLOOR LIFE

[ JEDEC MSL ] : Moisture Sensivity Level 1 (IPC/JEDEC J-STD-020E)  
MB85RS64TPNF-G-AME2 /MB85RS64TPNF-G-AMERE2

[ JEDEC MSL ] : Moisture Sensivity Level 3 (IPC/JEDEC J-STD-020E)  
MB85RS64TPNF-G-JNE1 /MB85RS64TPNF-G-JNERE1 /MB85RS64TPN-G-AMERE1

## ■ CURRENT STATUS ON CONTAINED RESTRICTED SUBSTANCES

This product complies with the regulations of REACH Regulations, EU RoHS Directive and China RoHS.

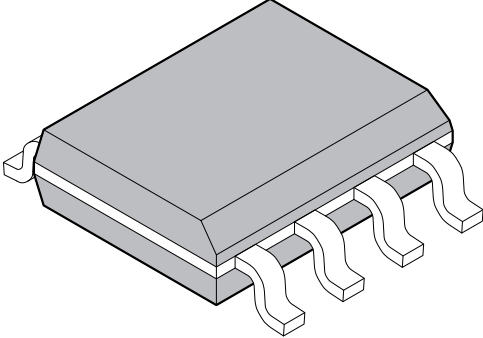
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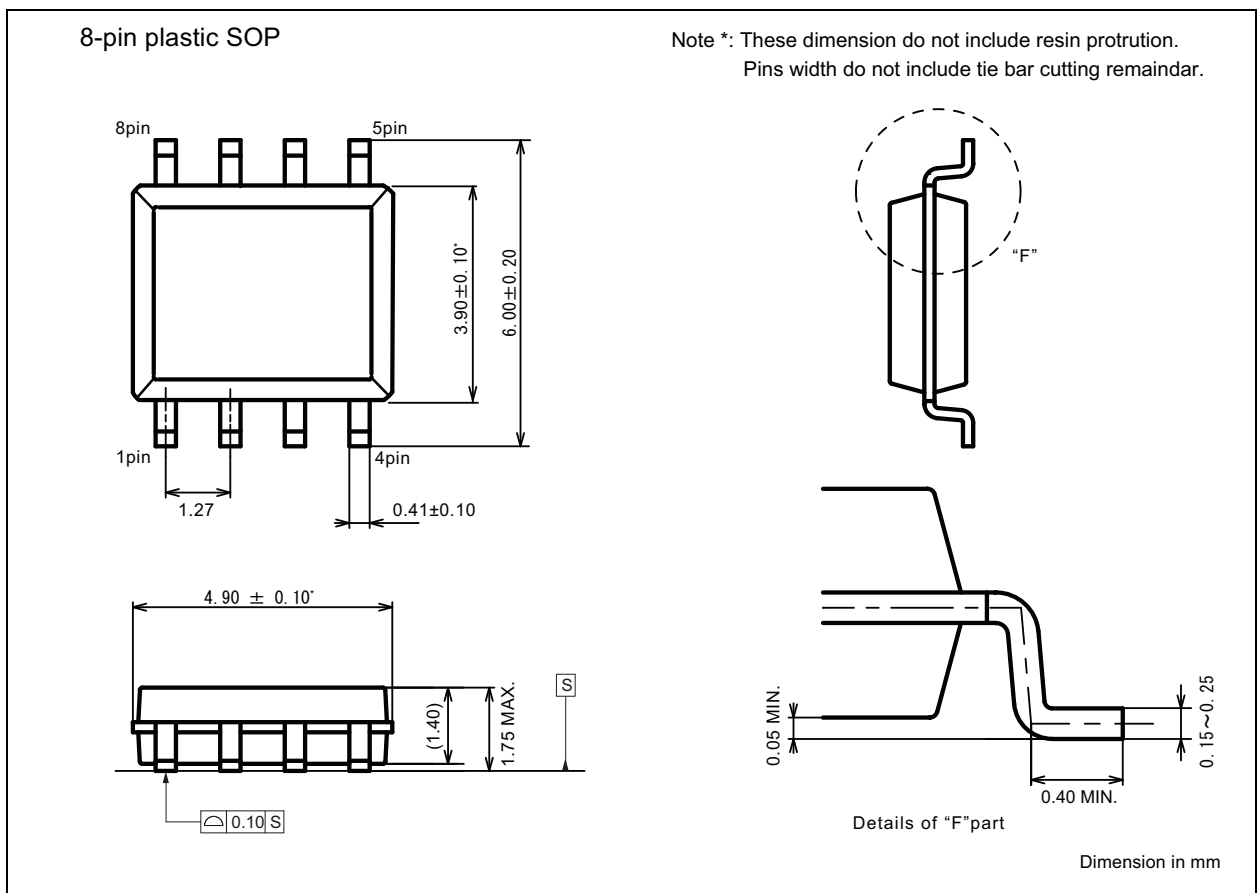
## ■ ORDERING INFORMATION

Part number	Package	Shipping form	Minimum shipping quantity
MB85RS64TPNF-G-JNE2	8-pin plastic SOP	Tube	—*
MB85RS64TPNF-G-JNERE2	8-pin plastic SOP	Embossed Carrier tape	1500
MB85RS64TPNF-G-AME2	8-pin plastic SOP	Tray	—*
MB85RS64TPNF-G-AMERE2	8-pin plastic SOP	Embossed Carrier tape	1500
MB85RS64TPN-G-AMEWE1	8-pin plastic SON	Embossed Carrier tape	1500

\*: Please contact our sales office about minimum shipping quantity.

## ■ PACKAGE DIMENSION

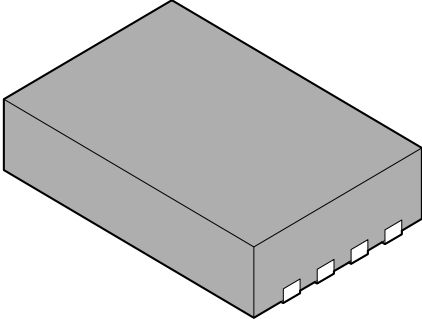
 <p>8-pin plastic SOP(150mil)</p>	Lead pitch	1.27mm
	Package width x Package length	3.90mm x 4.90mm
	Lead shape	Gullwing
	Sealing method	Plastic mold
	Mounting height	1.75mm MAX.

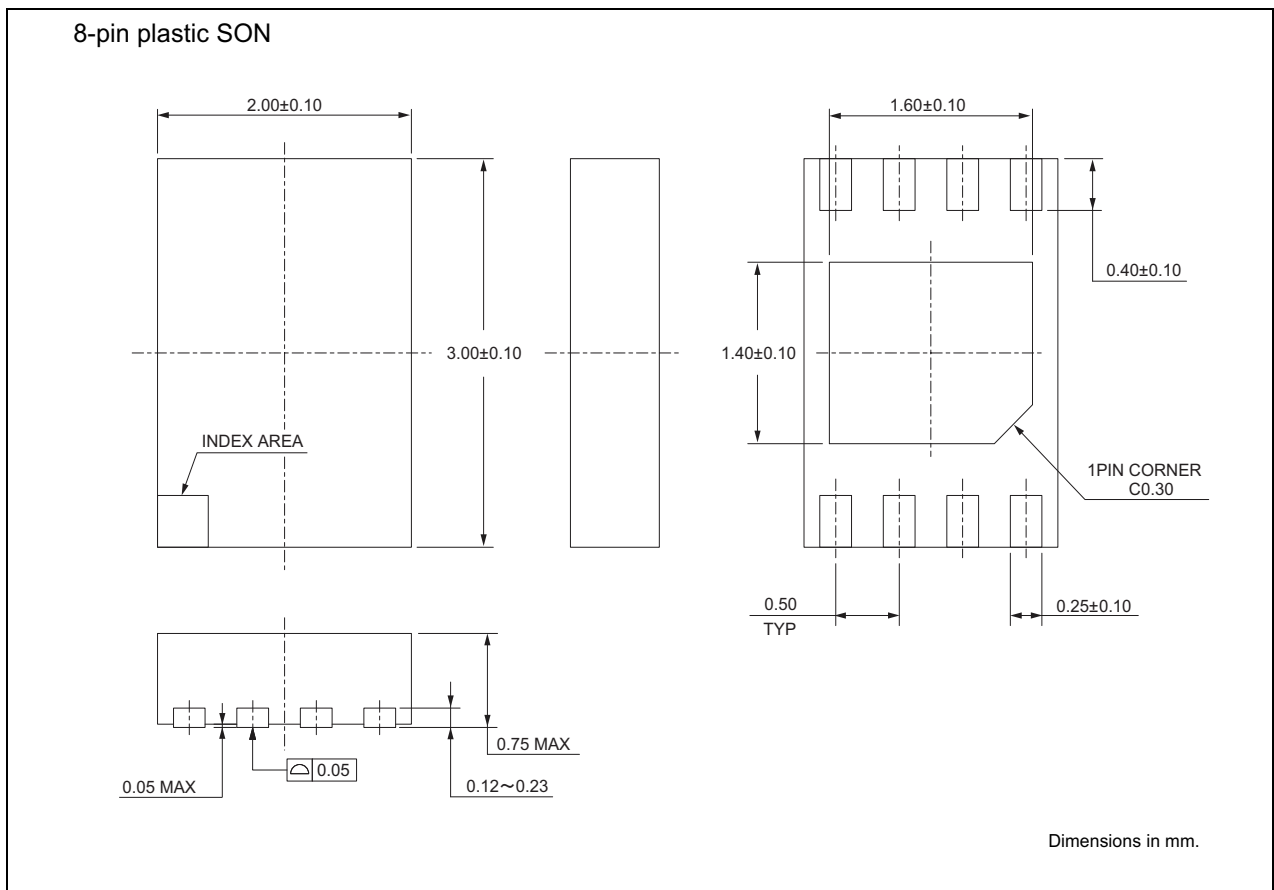


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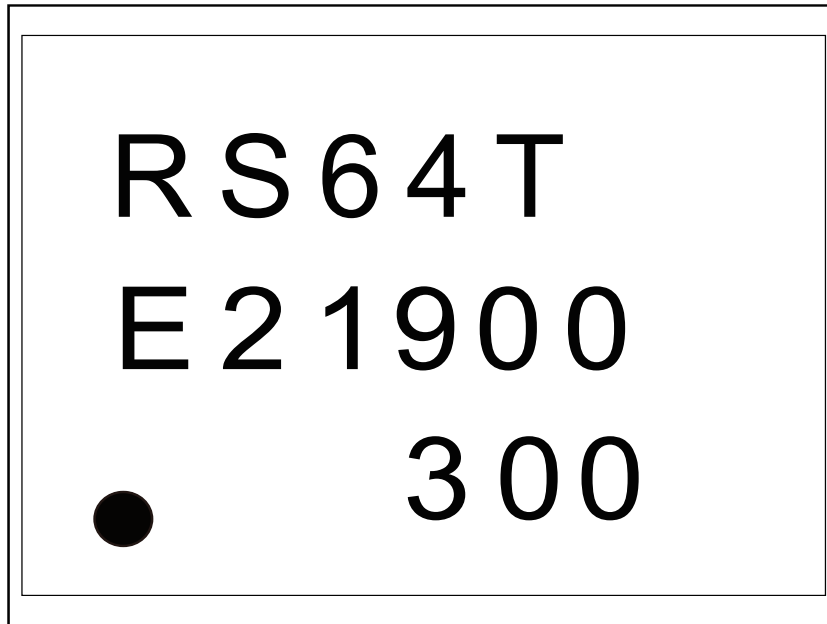
■ (continued)

<p>8-pin plastic SON</p> 	Lead pitch	0.50 mm
	Package width × package length	2.00 mm × 3.00 mm
	Sealing method	Plastic mold
	Mounting height	0.75 mm MAX



## ■ MARKING

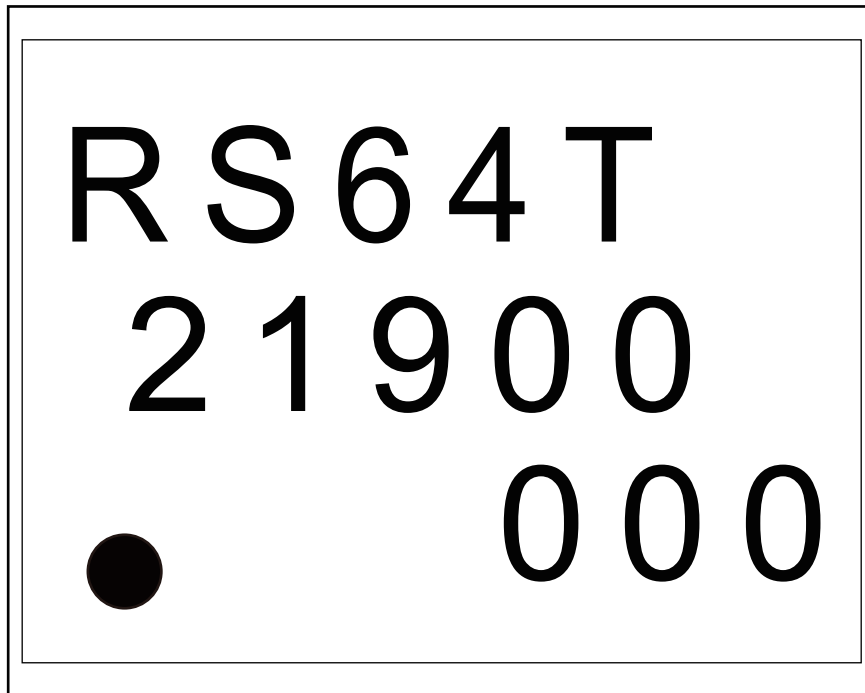
[MB85RS64TPNF-G-JNE2]  
[MB85RS64TPNF-G-JNERE2]



[8-pin plastic SOP, 150mil]

RS64T: Product name  
E21900: E2(Lead free code) + 1900(Year and Week code)  
300: Trace code:

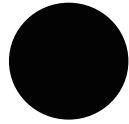
[MB85RS64TPNF-G-AME2]  
[MB85RS64TPNF-G-AMERE2]



[8-pin plastic SOP, 150mil]

RS64T: Product name  
21900: 2(Lead free code) + 1900(Year and Week code)  
000: Trace code:

[MB85RS64TPN-G-AMEWE1]



1900

S64T

000

[8-pin plastic SON]

1900: Year and Week code  
S64T: Product name  
000: Trace code:

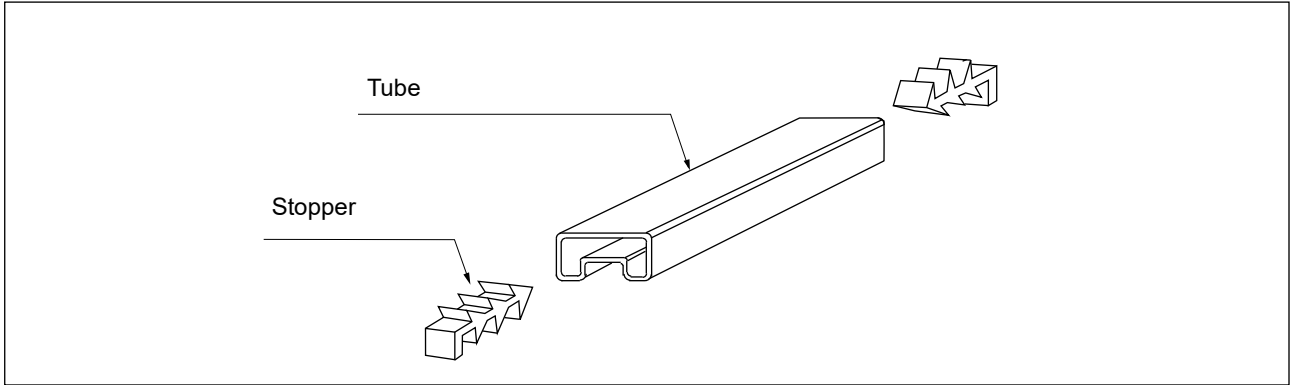
## ■ PACKING INFORMATION

(1)MB85RS64TPNF-G-JNE2/MB85RS64TPNF-G-JNERE2/MB85RS64TPNF-G-AMERE2/  
MB85RS64TPNF-G-AME2

### 1. Tube (MB85RS64TPNF-G-JNE2)

#### 1.1 Tube Dimensions

- Tube/stopper shape



#### Tube cross-sections and Maximum quantity

MB85RS64TPNF-G-JNE2	Maximum quantity		
	ICs/tube	ICs/inner box	ICs/outer box
	95	7,600	30,400

7.7

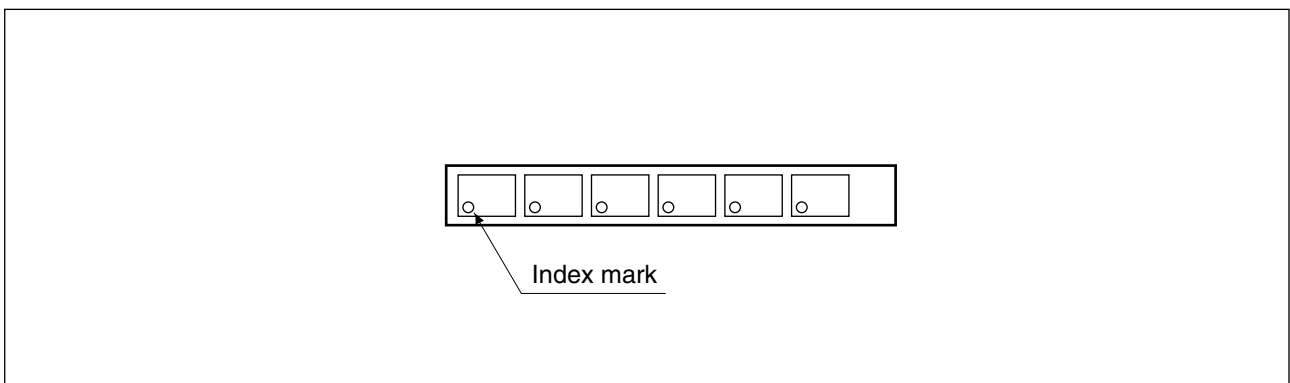
3.8

tube length:521

No heat resistance  
Package should not be baked by using tube.

(Dimensions in mm)

- Direction of index in tube



# MB85RS64T

## 1.2 Product label indicators (Example)

Label I: Label on Inner box/Moisture Barrier Bag/ (It sticks it on the reel for the emboss taping)  
 [C-3 Label (50mm × 100mm) Supplemental Label (20mm × 100mm)]

XXXXXXXXXXXXXXXX (Part number)

(3N)1 XXXXXXXXXXXXXXX XXX (LEAD FREE mark)  
 (Part number and quantity)

QC PASS

(3N)2 XXXXXXXXXXXXXXX XXXXXX  
 (Control number bar code)

XXX pcs (Quantity)  
 XXXXXXXXXXXXXXX (Part number)

XXXXXXXXXXXX (Part number bar code)

XXXX/XX/XX (Packed years/month/day) ASSEMBLED IN xxxx

XXXXXXXXXXXXXXXX (Part number)  
 (Control number bar code)

XX/XX XXXX-XXX XXX  
 (Package count) XXXX-XXX XXX

XXXXXXXXXXXX (Control number) (Lot Number and quantity)  
 XXXXXXXXXXXXXXX (Comment)

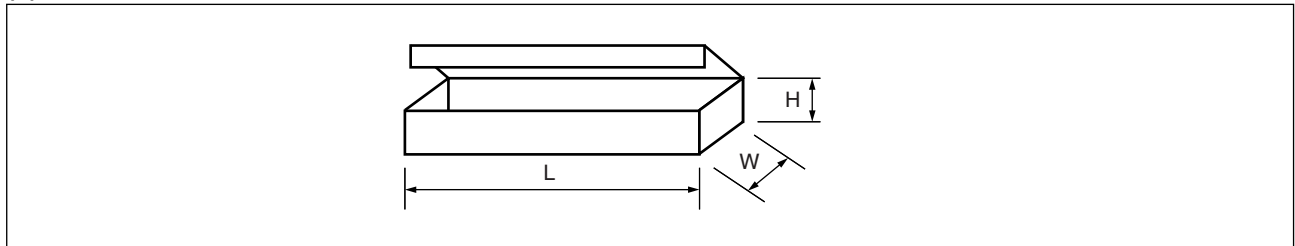
← C-3 Label

← Perforated line

← Supplemental Label

## 1.3 Dimensions for Containers

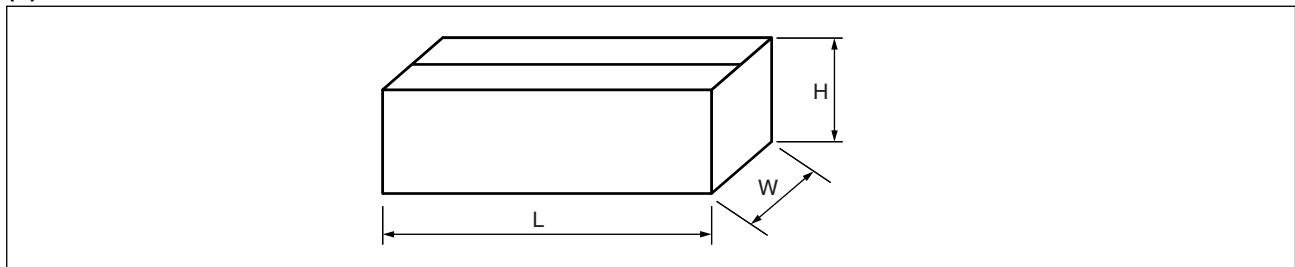
### (1) Dimensions for inner box



L	W	H
540	125	75

(Dimensions in mm)

### (2) Dimensions for outer box



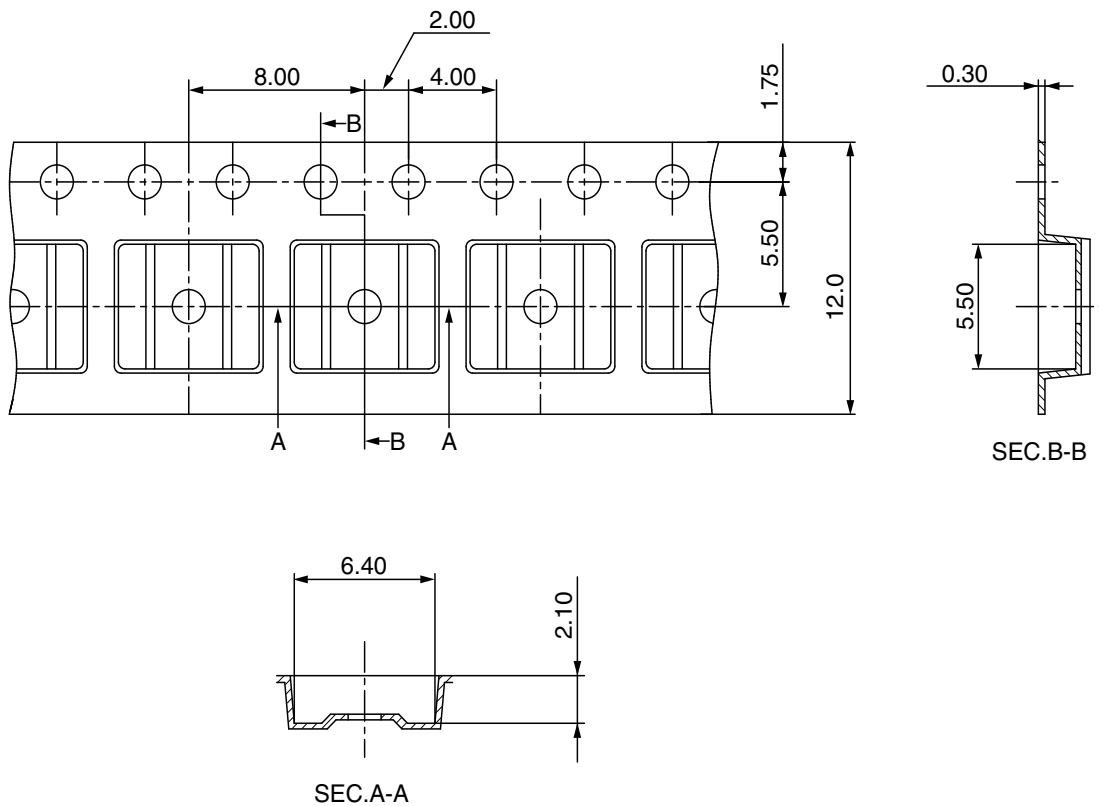
L	W	H
565	270	180

(Dimensions in mm)

## 2. Emboss Tape (MB85RS64TPNF-G-JNERE2/MB85RS64TPNF-G-AMERE2)

### 2.1 Tape Dimensions

Part number	reel diameter	Maximum storage capacity		
		ICs/reel	ICs/inner box	ICs/outer box
MB85RS64TPNF-G-JNERE2	φ330	1,500	1,500 (1 pack/inner box)	10,500 (7 inner boxes/ outer box:Max.)
MB85RS64TPNF-G-AMERE2	φ254	1,500	1,500 (1 pack/inner box)	9,000 (6 inner boxes/ outer box:Max.)

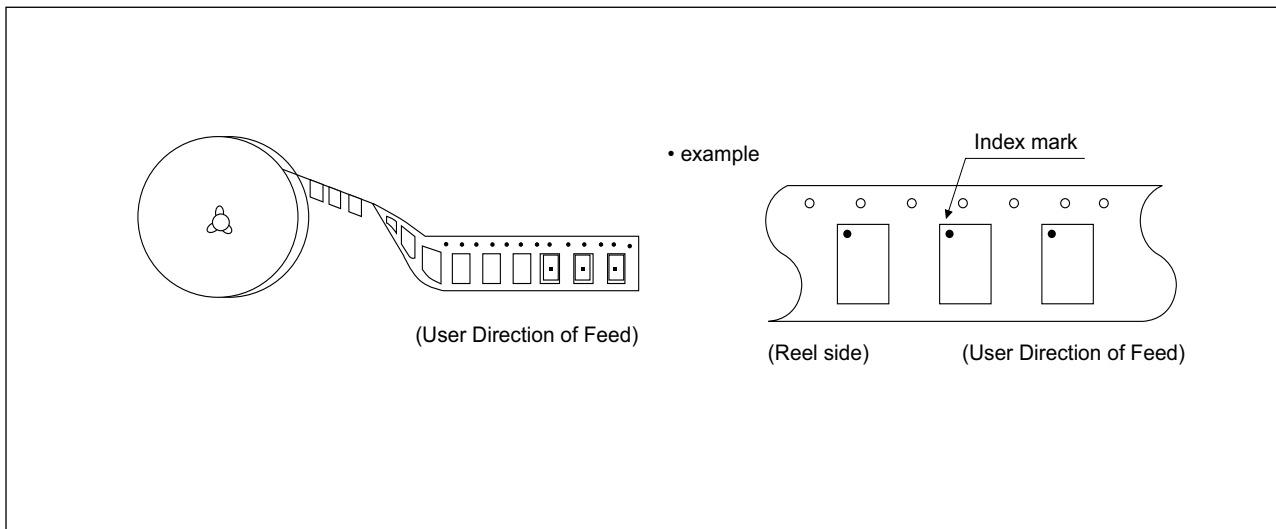


(Dimensions in mm)

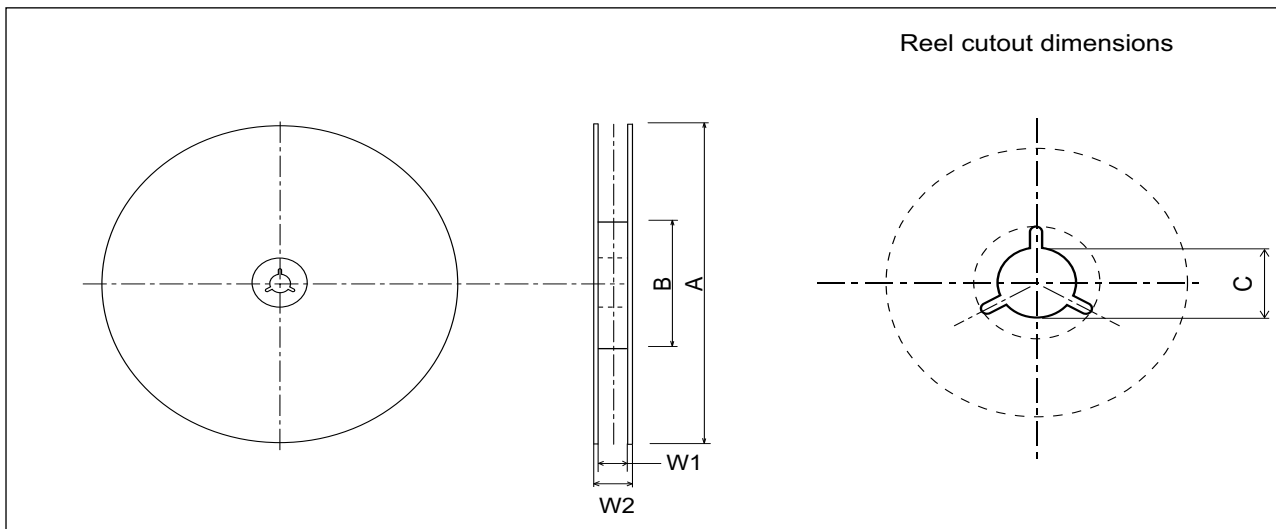
Heat proof temperature : No heat resistance.  
Package should not be baked by using tape and reel.

# MB85RS64T

## 2.2 IC orientation



## 2.3 Reel dimensions

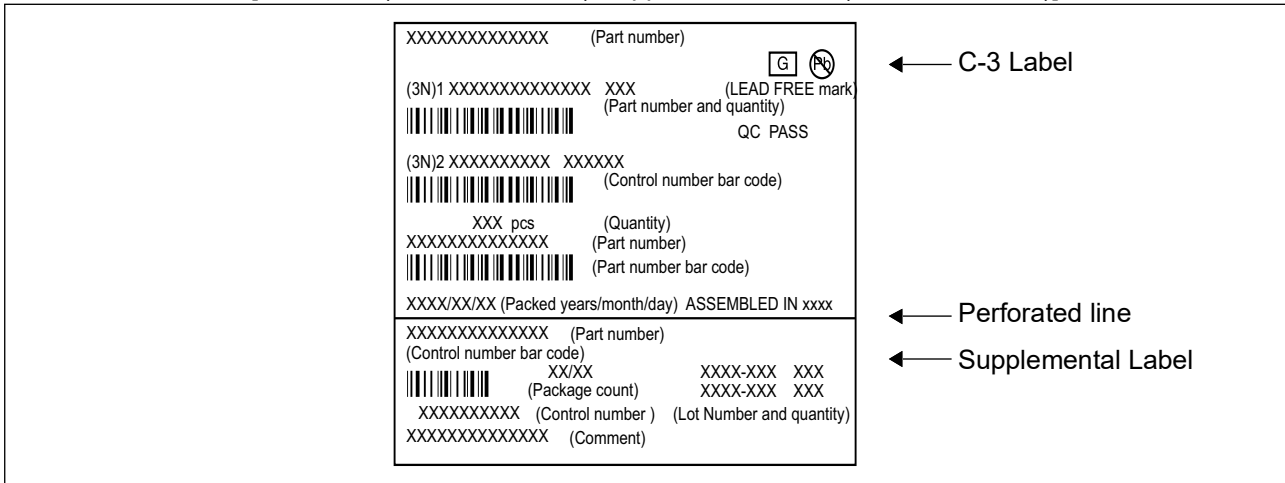


單位 : mm

型格	A	B	C	W1	W2
MB85RS64TPNF-G-JNERE2	330	100	13	12.4	17.2
MB85RS64TPNF-G-AMERE2	254	100	13	13.5	17.5

## 2.4 Product label indicators (Example)

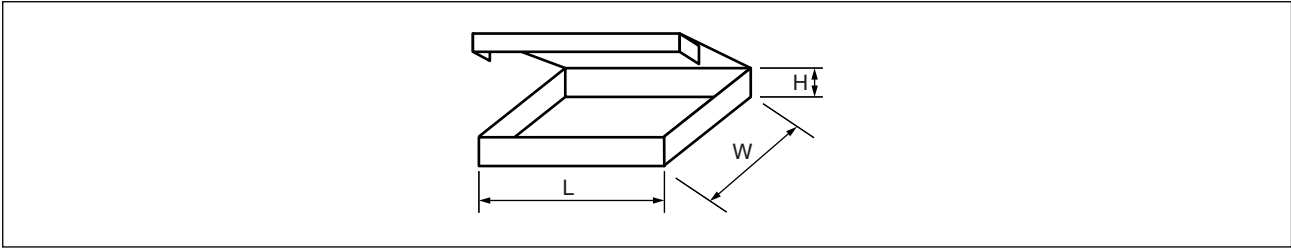
Label I: Label on Inner box/Moisture Barrier Bag/ (It sticks it on the reel for the emboss taping)  
 [C-3 Label (50mm × 100mm) Supplemental Label (20mm × 100mm)]



# MB85RS64T

## 2.5 Dimensions for Containers

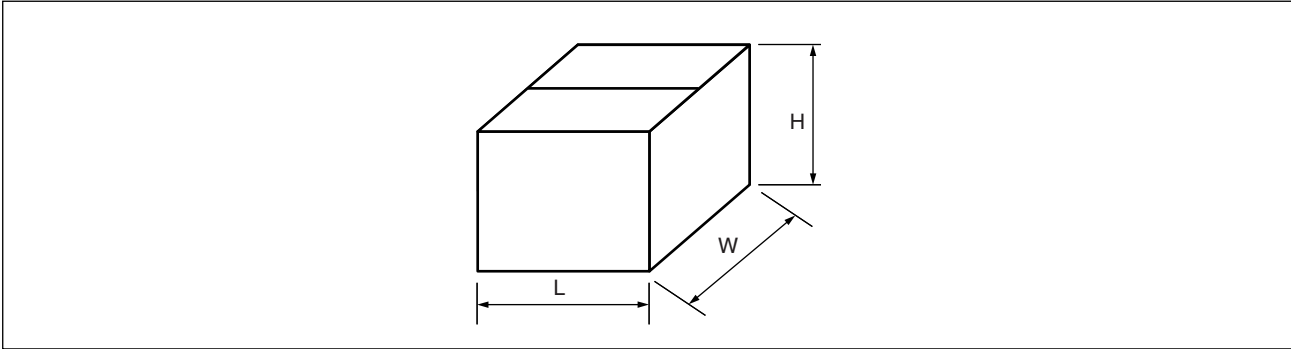
### (1) Dimensions for inner box



Part Number	L	W	H
MB85RS64TPNF-G-JNERE2	365	345	40
MB85RS64TPNF-G-AMERE2	265	260	50

(Dimensions in mm)

### (2) Dimensions for outer box



Part Number	L	W	H
MB85RS64TPNF-G-JNERE2	415	400	315
MB85RS64TPNF-G-AMERE2	565	270	180

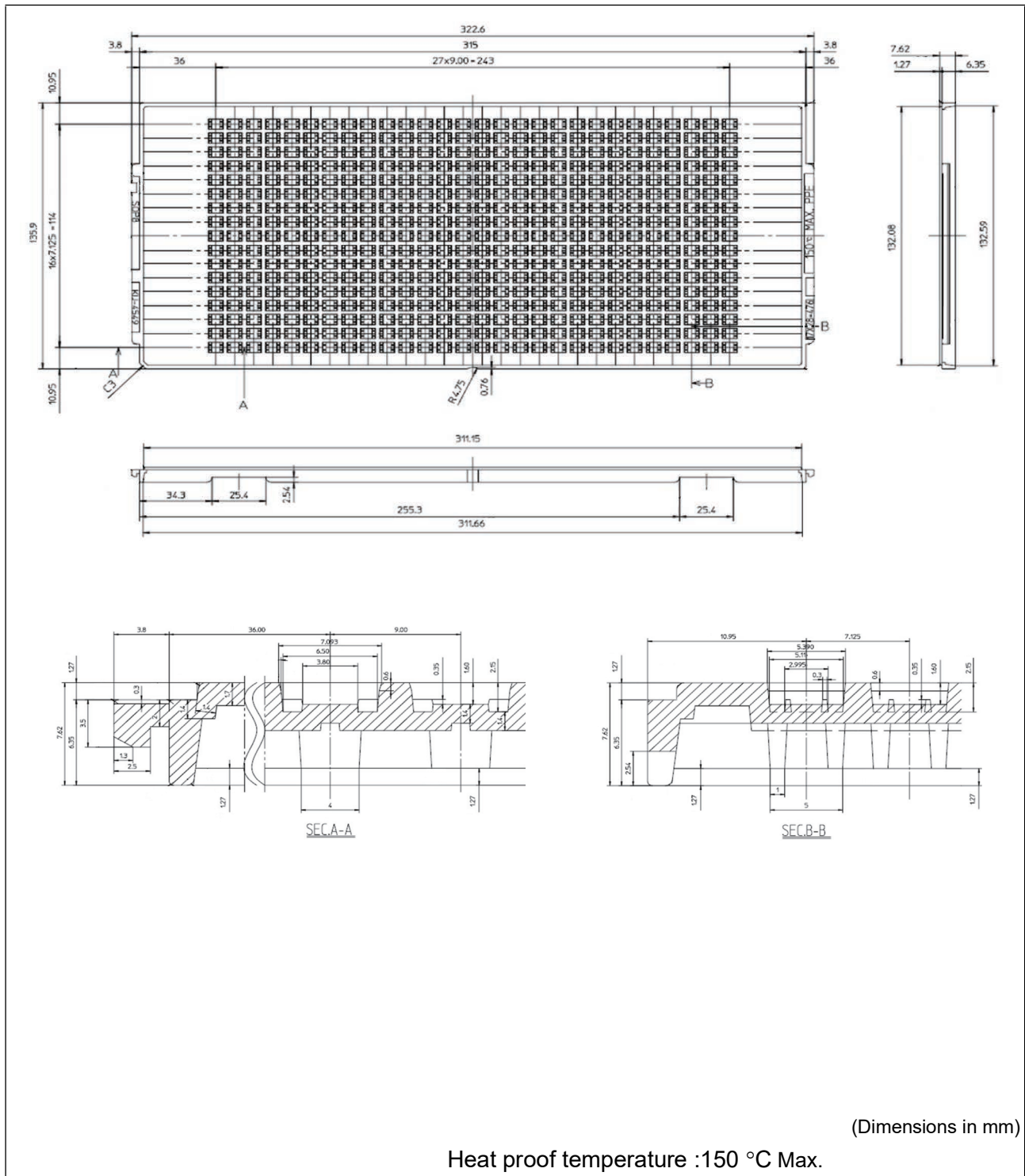
(Dimensions in mm)

## 3. Tray(MB85RS64TPNF-G-AME2)

### 3.1 Tray Storage Capacity

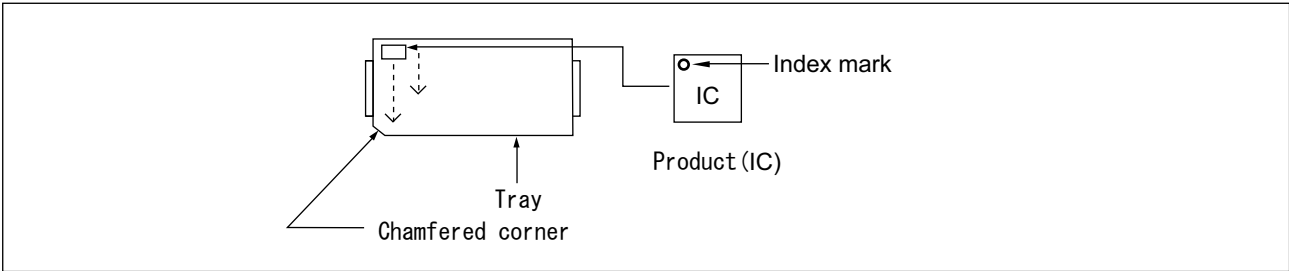
Maximum storage capacity		
ICs/tray	ICs/inner box	ICs/outer box
476	4,760 (Max:10 trays/inner box)	19,040 (Max: 4 inner boxes/outer box)

### 3.2 Tray Dimensions (JEDEC Standard)



# MB85RS64T

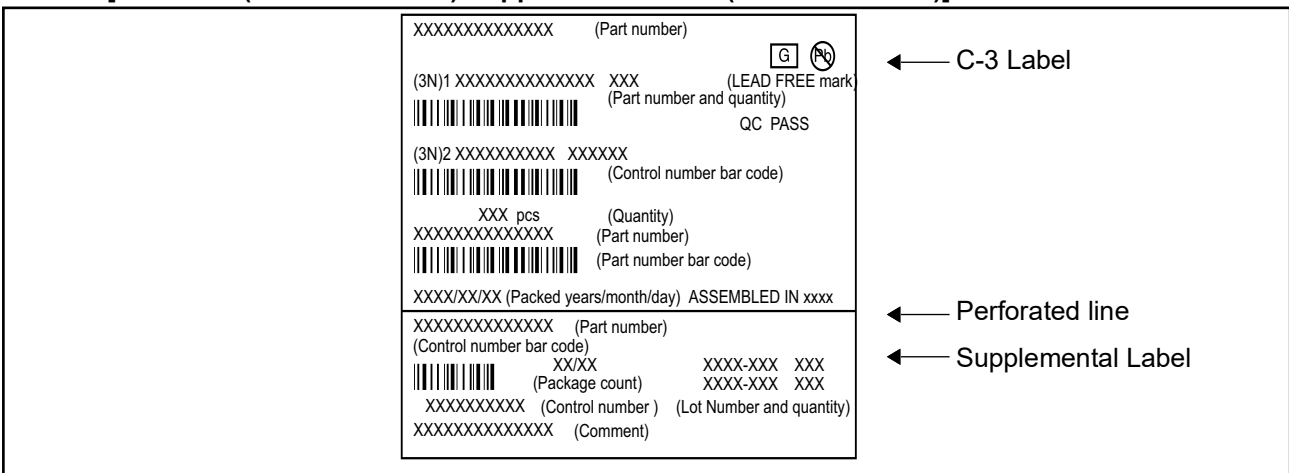
## 3.3 IC Orientation



## 3.4 Product label indicators (an example)

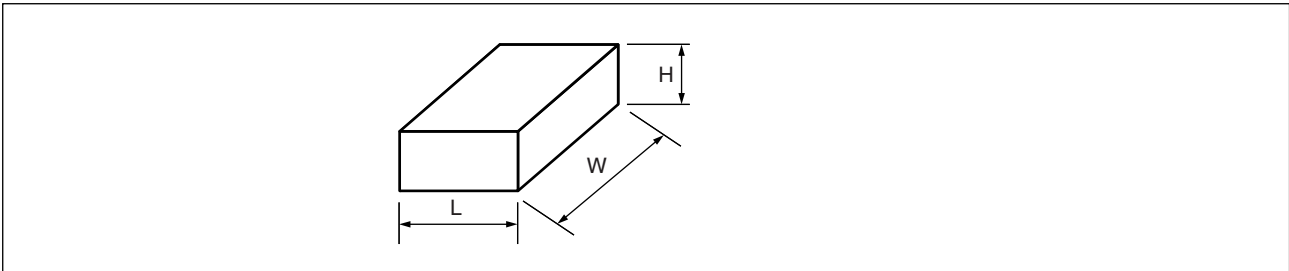
### Label on Inner box/Moisture Barrier Bag

#### [C-3 Label (50mm x 100mm) Supplemental Label (20mm x 100mm)]



## 3.5 Dimensions for Containers

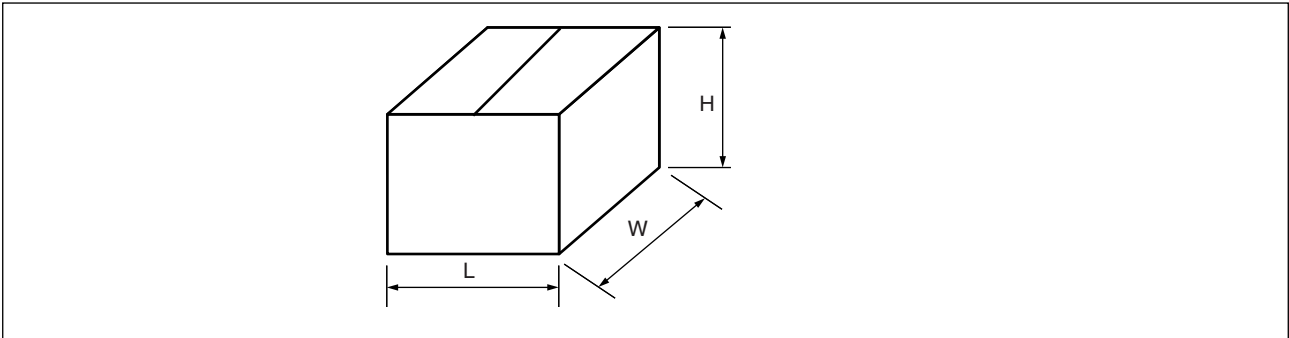
### (1) Dimensions for inner box



L	W	H
165	360	75

(Dimensions in mm)

### (2) Dimensions for outer box



L	W	H
355	385	195

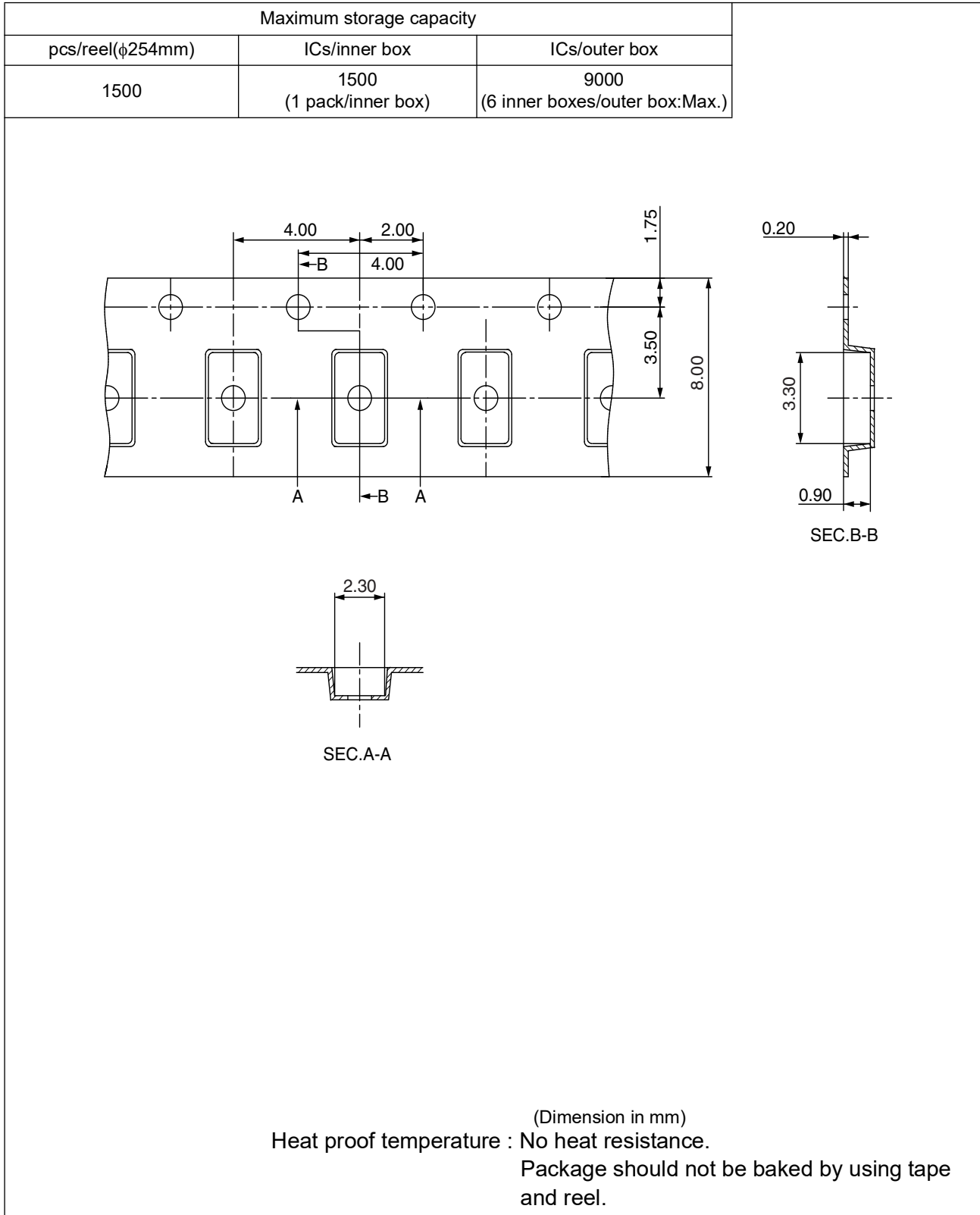
(Dimensions in mm)

# MB85RS64T

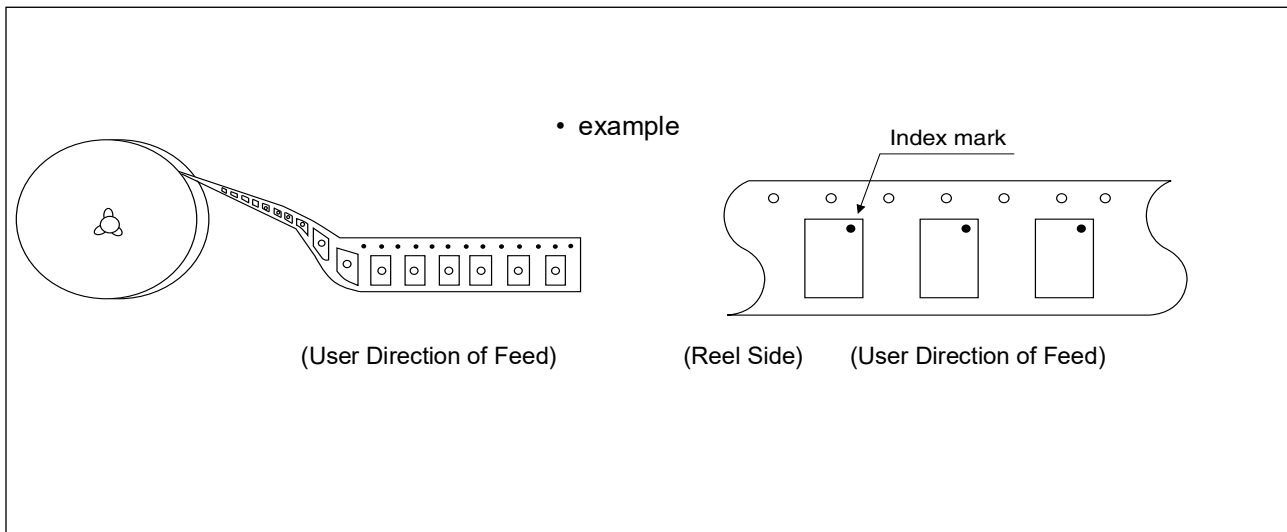
## (2)MB85RS64TPN-G-AMEWE1

### 1. Emboss Tape (MB85RS64TPN-G-AMEWE1)

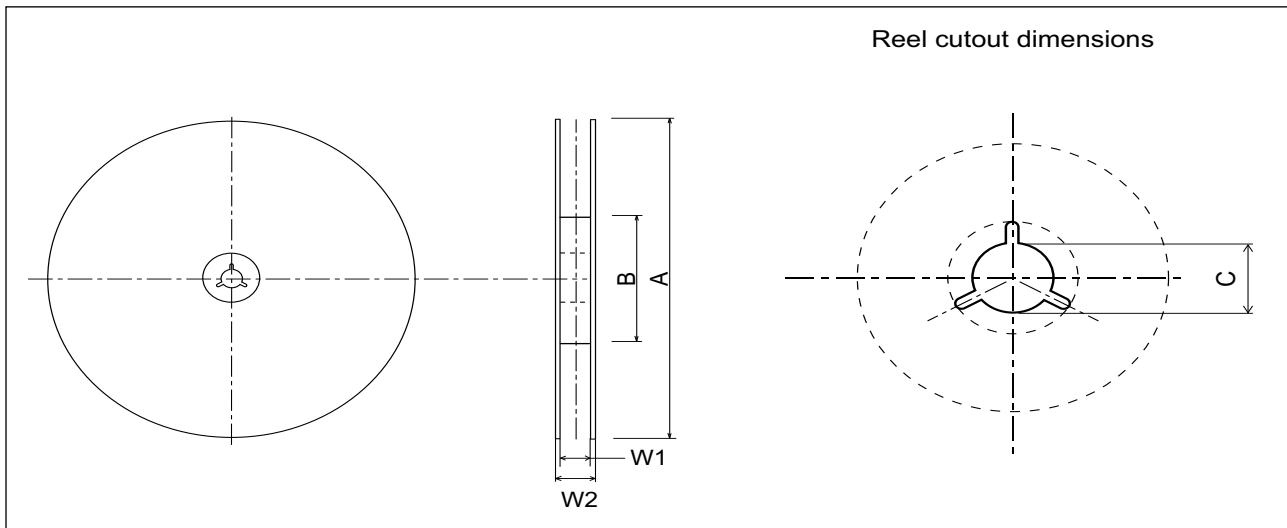
#### 1.1 Tape Dimensions (not drawn to scale) (8-pin plastic SON)



## 1.2 IC orientation



## 1.3 Reel dimensions

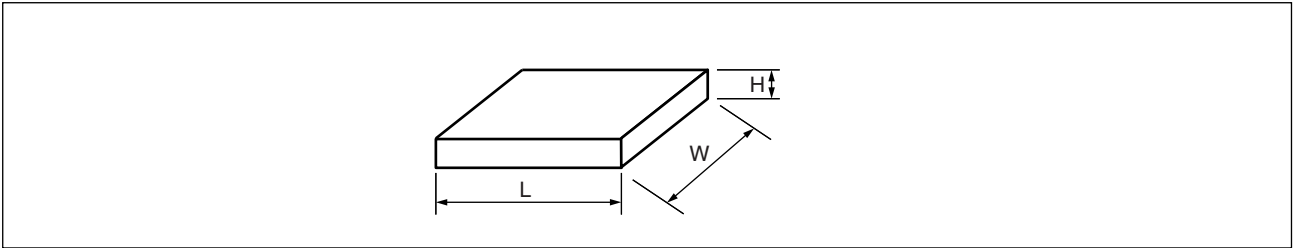


tape width	A	B	C	W1	W2
8	254	100	13	9.5	13.5



## 1.5 Dimensions for Containers

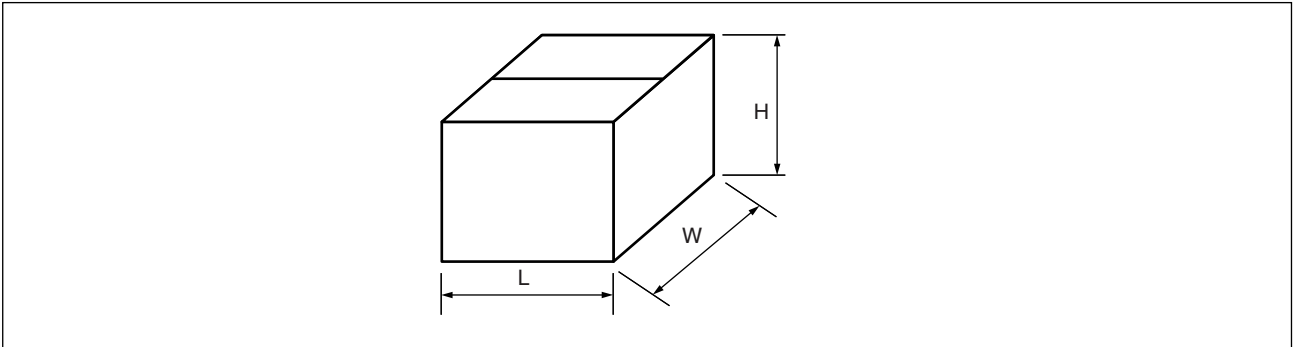
### (1) Dimensions for inner box



L	W	H
265	260	50

(Dimensions in mm)

### (2) Dimensions for outer box



L	W	H
565	270	180

(Dimensions in mm)

## ■ MAJOR CHANGES IN THIS EDITION

A change on a page is indicated by a vertical line drawn on the left side of that page.

Page	Section	Change Results
17	ESD AND LATCH-UP	Delete ESD MM and test with no value.
17	ESD AND LATCH-UP	Delete Current method.
17	REFLOW CONDITIONS AND FLOOR LIFE	Add Moisture Sensitivity Level 1.

# MB85RS64T

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